

EV12DS130AG EV12DS130BG Low Power 12-bit 3 Gsps Digital to Analog Converter with 4/2:1 Multiplexer Datasheet DS 60S 221070



MAIN FEATURES

- 12-bit Resolution
- 3 Gsps Guaranteed Conversion Rate
- 7 GHz Analog Output Bandwidth
- 4:1 or 2:1 integrated Parallel MUX (Selectable)
- Selectable Output Modes for performance optimization:
- Return to Zero, Non Return to Zero, Narrow Return to Zero, RF
- Low Latency Time: 3.5 Clock Cycles
- 1.4 Watt Power Dissipation in MUX 4:1 Mode
- Functions
 - Selectable MUX Ratio 4:1 (Full Speed), 2:1 (Half Speed)
 - o Triple Majority Voting
 - o User-friendly Functions:
 - o Gain Adjustment
 - o Input Data Check Bit (FPGA Timing Check)
 - o Setup Time and Hold Time Violation Flags (STVF, HTVF)
 - Clock Phase Shift Select for Synchronization with DSP (PSS[2:0])
 - o Output Clock Division Selection (Possibility to Change the Division Ratio of the DSP Clock)
 - o Input Under Clocking Mode
 - o Diode for Die junction Temperature Monitoring
- LVDS Differential Data input and DSP Clock Output
- Analog Output Swing: 1V_{pp} Differential (100Ω Differential Impedance)
- External Reset for Synchronization of Multiple MuxDACs
- Power Supplies: 3.3 V (Digital), 3.3V & 5.0V (Analog)
- LGA255, CCGA255, Ci-CGA255 Package (21 × 21 mm Body
- Size, 1.27 mm Pitch)
- MSL 1 (Moisture Sensitivity Level)

PERFORMANCES

Broadband: NPR at –14 dB Loading Factor, (See Section 7.2.7 NPR Performance on page 57)

- 1st Nyquist (NRTZ): NPR = 51.3 dB 10.0 Bit Equivalent at Fs = 3 Gsps
- 1st Nyquist (NRTZ): NPR = 55.7 dB 10.8 Bit Equivalent at Fs = 1.5 Gsps
- 2nd Nyquist (NRTZ or RTZ): NPR = 44.6 dB 8.9 Bit Equivalent at Fs = 3 Gsps
- 3rd Nyquist (RF): NPR = 42.5 dB 8.6 Bit Equivalent at Fs = 3 Gsps

Single Tone: (see FUNCTIONAL DESCRIPTION on page 15)

- · Performances Characterized for Fout from 100 MHz to
- 4500 MHz and from 2 Gsps to 3.2 Gsps
- Performance Industrially Screened Over 3 Nyquist Zones at 3 Gsps for Selected Fout.

Step Response

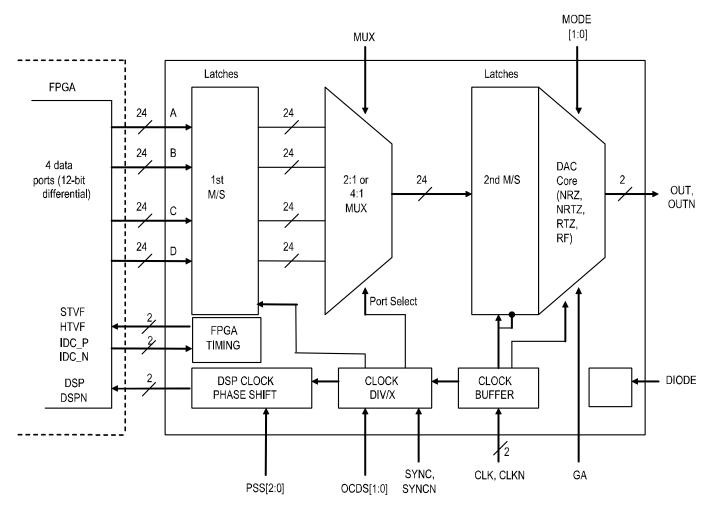
• Full Scale Rise / Fall Time 60 ps

APPLICATIONS

- Direct Digital Synthesis for Broadband Applications (L-S and Lower C Band)
- Automatic Test Equipment (ATE)
- Arbitrary Waveform Generators
- Radar Waveform Signal Synthesis
- DOCSIS V3.0 Systems

1. BLOCK DIAGRAM

Figure 1-1. Simplified Block Diagram



2. DESCRIPTION

The EV12DS130A/B is a 12-bit 3 Gsps DAC with an integrated 4:1 or 2:1 multiplexer, allowing easy interface with standard LVDS FPGAs thanks to user friendly features as OCDS, PSS.

It embeds different output modes (RTZ, NRZ, narrow RTZ, RF) that allow performance optimizations depending on the working Nyquist zone.

The Noise Power Ratio (NPR) performance, over more than 900 MHz instantaneous bandwidth, and the high linearity (SFDR, IMD) over full 1st Nyquist zone at 3 Gsps (NRZ feature), make this product well suited for high-end applications such as arbitrary waveform generators and broadband DDS systems.

3. ELECTRICAL CHARACTERISTICS

3.1 Absolute Maximum Ratings

Table 3-1. Absolute Maximum Ratings

Parameter	Symbol	Value	Unit
Positive Analog supply voltage	V _{CCA5}	6.0	V
Positive Analog supply voltage	V _{CCA3}	4.0	V
Positive Digital supply voltage	V _{CCD}	4.0	V
Digital inputs (on each single-ended input) and IDC, SYNC, signal Port P = A, B, C, D V_{IL} V_{IH} Digital Input maximum Differential mode swing	[P0P11], [P0N P11N] IDC_P, IDC_N SYNC, SYNCN	GND-0.3 V _{CCA3} 2.0	V V Vpp
Master clock input (on each single-ended input) V _{IL} V _{IH} Master Clock Maximum Differential mode swing	CLK, CLKN	1.5 3.5 2.5	V V Vpp
Control functions inputs V_{IL} V_{IH}	MUX, MODE[01], PSS[02], OCDS[01]	-0.4V V _{CCD} + 0.4	V V
Gain Adjustment function	GA	-0.3V, V _{CCA3} + 0.3	V
Maximum Junction Temperature	Tj	170	°C
Storage Temperature	Tstg	–65 to 150	°C
Electrostatic discharge immunity ESD Classification	ESD HBM	1000 Class 1B	V

Notes:

1. Absolute maximum ratings are limiting values (referenced to GND = 0V), to be applied individually, while other parameters are within specified operating conditions. Long exposure to maximum rating may affect device reliability.

- 2. All integrated circuits have to be handled with appropriate care to avoid damages due to ESD. Damage caused by inappropriate handling or storage could range from performance degradation to complete failure.
- 3. Maximum ratings enable active inputs with DAC powered off.
- 4. Maximum ratings enable floating inputs with DAC powered on.
- 5. DSP clock and STVF, HTVF output buffers must not be shorted to ground nor positive power supply.

3.2 Recommended Conditions of Use

Table 3-2. Recommended Conditions of Use

Parameter	Symbol	Comments	Recommended Value	Unit	Note
Positive analog supply voltage	V _{CCA5}		5.0	V	(2)(4)
Positive analog supply voltage	V _{CCA3}		3.3	V	(1)(2)(4)
Positive digital supply voltage	V _{CCD}		3.3	V	(2)(4)
Digital inputs (on each single-ended input) and IDC, SYNC, signal Port P = A, B, C, D V_{IL} V_{IH} Differential mode swing	[P0P11], [P0N P11N] IDC_P, IDC_N SYNC, SYNCN		1.075 1.425 700	V Vm V _{pp}	(3)
Master clock input power level (Differential mode)	PCLK		3	dBm	(3)
Control functions inputs	MUX, OCDS, PSS, MODE, PSS	V _{IL} V _{IH}	0 V _{CCD}	V V	
Gain Adjustment function	GA	Range	0 V _{CCA3}	V	
Operating Temperature Range	Tc = Tcase Tj = T junction	Military "M" & space grade	–55°C < Tc, Tj < 125°C	°C	

Notes:

1. For low temperature it is recommended to operate at maximum analog supplies (V_{CCA3}) level.

 The rise time of any power supplies (Vccd, Vcca5, Vcca3) shall be <10ms. For EV12DS130A, in order to obtain the guaranteed performances and functionality, the following rules shall be followed when powering the devices (See Section 8.9 Power Up Sequencing on page 68) For EV12DS130B, no specific power up sequence nor power supplies relationships are required.

- 3. Analog output is in differential. Single-ended operation is not recommended. Guaranteed performance is only in differential configuration.
- 4. No power-down sequencing is required.

3.3 Electrical Characteristics

Values in the tables below are based on our conditions of measurement and valid over temperature range respectively for M, and Space quality level and for typical power supplies ($V_{CCA5} = 5.0V$, $V_{CCA3} = 3.3V$, $V_{CCD} = 3.3V$), typical swing, unless specified and in MUX4:1 mode.

Table 3-3. Electric Characteristics

Parameter	Symbol	Min	Тур	Мах	Unit	Note	Test Level ⁽²⁾
RESOLUTION			12		bit		1,6
POWER REQUIREMENTS	I						1
Power Supply voltage - Analog - Analog - Digital	V _{CCA5} V _{CCA3} V _{CCD}	4.75 3.15 3.15	5 3.3 3.3	5.25 3.45 3.45	V V	(7) (8)	1,6
Power Supply current (4:1 MUX) - Analog - Analog - Digital	ICCA5 ICCA3 ICCD		84 106 187	92 125 213	mA mA mA		1,6
Power Supply current (2:1 MUX) - Analog - Analog - Digital	ICCA5 ICCA3 ICCD		84 106 160	92 125 185	mA mA mA		1,6
Power dissipation (4:1 MUX)	P _D		1.4	1.6	W		1,6
Power dissipation (2:1 DMUX)	PD		1.3	1.5	W		1,6
DIGITAL DATA INPUTS, SYNC and IDC INPUTS							
Logic compatibility			LVDS				
Digital input voltages: - Differential input voltage - Common mode	V _{ID} V _{ICM}	100	350 1.25	500	mV _p V		1,6 4
Input capacitance from each single input to ground				2	pF		5
Differential Input resistance		80	100	120	Ω		1,6
CLOCK INPUTS	•		•	•	•		1
Input voltages (Differential operation swing)		0.56	1	2.24	Vpp		4
Power level (Differential operation)		-4	1	8	dBm	(1)	4
Common mode		2.4	2.5	2.6	V		4
Input capacitance from each single input to ground (at die level)			2		pF		5
Differential Input resistance		80	100	120	Ω		1,6
DSP CLOCK OUTPUT			·	·			
Logic compatibility			LVDS				
Digital output voltages:							
- Differential output voltage - Common mode	V _{OD} V _{OCM}	240	350 1.30	450	mV _p V		1,6 4
ANALOG OUTPUT							
Full-scale Differential output voltage (100 Ω differentially terminated)		0.92	1	1.08	V_{pp}		1,6

Parameter	Symbol	Min	Тур	Мах	Unit	Note	Test Level ⁽²⁾
Full-scale output power (differential output)		0.25	1	1.64	dBm		1,6
Single-ended mid-scale output voltage (50 Ω terminated)			$V_{CCA5} - 0.43$		V	(4)	
Output capacitance			1.5		pF		5
Output internal differential resistance		90	100	110	Ω		1, 6
Output VSWR (using e2v evaluation board) 1.5 GHz 3 GHz 4.5 GHz			1.17 1.54 1.64				4
Output bandwidth			6		GHz		4
FUNCTIONS							
Digital functions: MODE, OCDS, PSS, MUX - Logic 0 - Logic 1 - Input Current	Vil Vih Iin	1.6	0 V _{CCD}	0.8 150	V V µA	(6)	
Gain Adjustment function	GA	0	0 V _{CCA3}				1,6
Digital output function (HTVF, STVF) - Logic 0 - Logic 1 - Output Current	V _{ol} Voh Io	_ 2.1	-	0.8 80	V V µA	(5) (6)	1,6
DC ACCURACY	•	1		1	1	1	1
Differential Non-Linearity	DNL+			0.95	LSB		1,6
Differential Non-Linearity	DNL-	-0.95			LSB		1,6
Integral Non-Linearity	INL+			3	LSB		1,6
Integral Non-Linearity	INL-	-3			LSB		1,6
DC gain: - Initial gain error - DC gain adjustment - DC gain sensitivity to power supplies - DC gain drift over temperature		-8	0 ±11 ±2	+8 +6	% % % %	(3)	1,6 4 1,6 4

Notes:

- 1. For use in higher Nyquist zone, it is recommended to use higher power clock within the limit.
- 2. See Section 3.6 Explanation of Test Levels on page 13.
- 3. Initial gain error corresponds to the deviation of the DC gain center value from unity gain. The DC gain adjustment (GA function) ensures that the initial gain deviation can be cancelled. The DC gain sensitivity to power supplies is given according the rule:
 - GainSensVsSupply = |Gain@VccMin Gain@VccMax| / Gain@Vccnom
- 4. Single-ended operation is not recommended, this line is given for better understanding of what is output by the DAC.
- 5. In order to modify the VoL/VoH value, potential divider could be used.
- 6. Sink or source.
- Only for EV12DS130A dependency between power supplies: Within the applicable power supplies range, the following relationship shall always be satisfied V_{CCA3} ≥ V_{CCD}, taking into account AGND and DGND planes are merged and power supplies accuracy.
- 8. Please refer Section 8.9 "Power Up Sequencing" on page 68.

3.4 AC Electrical Characteristics

Values in the tables below are based on our conditions of measurement and valid over temperature range respectively for M, and Space quality level and for typical power supplies ($V_{CCA5} = 5.0V$, $V_{CCA3} = 3.3V$, $V_{CCD} = 3.3V$), typical swing, unless specified and in MUX4:1 mode.

Table 3-4. AC Elect	rical Characteristics	NRZ Mode	(First Nv	auist Zone)
			(1 11 01 11)	quiot cono,

Parameter	Symbol	Min	Тур	Мах	Unit	Note	Test level ⁽¹⁾
Single-tone Spurious Free Dynamic Range First Nyquist	SFDR				dBc		
Fs = 3 GSps @ Fout = 100 MHz 0 dBFS Fs = 3 GSps @ Fout = 400 MHz 0 dBFS		57	68 63				1,6 4
Fs = 3 GSps @ Fout = 400 MHz - 3 dBFS		59	70				1,6
Highest spur level First Nyquist					dBm		
Fs = 3 GSps @ Fout = 100 MHz 0 dBFS			-68	-56			1,6
Fs = 3 GSps @ Fout = 400 MHz 0 dBFS Fs = 3 GSps @ Fout = 100 MHz -3 dBFS			61 72	-60			4 1,6
SFDR sensitivity & high spur level variation over power supplies			±2		dB		4
Signal independent Spur (clock-related spur) Fc/2			-82		dBm		4
Fc/4			-85		dBm		4
Noise Power Ratio –14 dBFS peak to rms loading factor Fs = 3 GSps 20 MHz to 900 MHz broadband pattern, 25 MHz notch centered on 450 MHz	NPR	45	49		dB	(2)	1,6
Equivalent ENOB Computed from NPR figure at 3 GSps	ENOB	9	9.6		Bit	(2)	1,6
Signal to Noise Ratio Computed from NPR figure at 3 GSps	SNR	56	58		dB	(2)	1,6
DAC self noise density at code 0 or 4095			-163	-154	dBm/Hz		1,6

Notes:

1. See Section 3.6 on page 13 for explanation of test levels.

2. Figures in tables are derived from industrial screening; for practical reasons (necessity to cover also 2nd and 3rd Nyquist Zones) the balun used for industrial test is not optimum for first Nyquist performances, and results when Fout or folded low order hamonics are between DC to 400 MHz are very pessimistic. For further details please refer to Section 7.2 on page 38 for effect of the balun on performances.

Table 3-5. AC Electrical Characteristics NRTZ Mode (First & Second Nyquist Zone)

Fs = 3 GSps @ Fout = 100 MHz 0 dBFS 60 68 60 68 60 68 60 68 1.6	Parameter	Symbol	Min	Тур	Мах	Unit	Note	Test level(1)
Fs = 3 GSps @ Fout = 100 MHz 0 dBFS 60 68 60 68 60 68 60 68 1.6	Single-tone Spurious Free Dynamic Range	SFDR				dBc		
Fs = 3 GSps @ Fout = 700 MHz 0 dBFS 55 62 61 1.6 1.6 Fs = 3 GSps @ Fout = 700 MHz 0 dBFS 57 66 65 1.6 1.6 Highest spur level MUX2:1 57 65 62 -70 -62 -64 -56 1.6 Fs = 3 GSps @ Fout = 700 MHz 0 dBFS Fs = 3 GSps @ Fout = 700 MHz 0 dBFS -70 -62 -64 -56 1.6 1.6 Fs = 3 GSps @ Fout = 700 MHz 0 dBFS Fs = 3 GSps @ Fout = 700 MHz 0 dBFS -70 -62 -67 -57 46B 1.6 Fs = 3 GSps @ Fout = 700 MHz 0 dBFS Fs = 1.5 GSps @ Fout = 700 MHz 0 dBFS -67 -57 -62 -67 -56 -67 -56 1.6	MUX4:1							
Fs = 3 GSps @ Fout = 1000 MHz 0 dBFS 52 61 1.6 Fs = 1.5 GSps @ Fout = 700 MHz 0 dBFS 57 66 65 1.6 Highest spur level MUX4:1 65 65 65 1.6 MUX4:1 GSps @ Fout = 100 MHz 0 dBFS -70 -62 -56 -57 1.6								
Fs = 3 GSps @ Fout = 700 MHz 0 dBFS 57 66 65 66 65 66 65 1.6 1.6 Highest spur level MUX2:1 Fs = 3 GSps @ Fout = 700 MHz 0 dBFS 57 66 65 66 65 66 65 1.6								
MUX2: 1 57 66 65 1.6 1.6 Highest spur level MUX4: 1 MUX4: 1 65 65 4Bm 1.6 Highest spur level MUX4: 1 MUX4: 1 -62			52	61				1,6
Fs = 1.5 GSps @ Fout = 700 MHz 0 dBFS 51 65 Image: Market Mittage: Market Mittage								
Highest spur level MUX4:1Image: Spire (South = 100 MHz 0 dBFS Fs = 3 GSps @ Fout = 1800 MHz 0 dBFS Fs = 3 GSps @ Fout = 1800 MHz 0 dBFS Fs = 3 GSps @ Fout = 1800 MHz 0 dBFS Fs = 3 GSps @ Fout = 700 MHz 0 dBFS Fs = 3 GSps @ Fout = 700 MHz 0 dBFS Fs = 3 GSps @ Fout = 700 MHz 0 dBFS SF = 3 GSps @ Fout = 100 MHz 0 dBFS SF = 3 GSps @ Fout = 100 MHz 0 dBFS SF = 3 GSps @ Fout = 100 MHz 0 dBFS SF = 3 GSps @ Fout = 100 MHz 0 dBFS SF = 3 GSps @ Fout = 100 MHz 0 dBFS SF = 3 GSps @ Fout = 100 MHz 0 dBFSImage: Graph of the fourth of the f	-							
MX_{341}^{V} : Fs = 3 GSps @ Fout = 100 MHz 0 dBFS Fs = 3 GSps @ Fout = 700 MHz 0 dBFS 1.6 Fs = 3 GSps @ Fout = 1800 MHz 0 dBFS -3 dBFS -70 -62 -57 -57 Fs = 3 GSps @ Fout = 700 MHz 0 dBFS -70 -62 -57 -57 1.6 Fs = 1 GSps @ Fout = 700 MHz 0 dBFS -70 -62 -57 1.6 1.6 Stgnal independent Spur (clock-related spur) -70 -62 -63 -64 4 Fc/2 dB 4 4 Fc/2 dB 4 4 Fc/4 -80 dBm 4 DAC self noise density at code 0 or 4095 -40 -149 -143 dBm/Hz 1.6 Noise Power Ratio -144 DS pack to rms loading factor 50.2 50.2 dB (2) 1.6 Fs = 3 GSps DMLz to 300 MHz broadband pattern, 25 MHz notch centered on 450 MHz SNR 56.5 61.2 dB (2) 1.6 Noise Power Ratio -144 DS pack to rms loading factor Fs -3 GSps 65.5 61.2 dB (2) 1.6 Signal to Noise Ratio NPR <	Fs = 1.5 GSps @ Fout = 700 MHz 0 dBFS		51	65				1,6
MUX41: Fs = 3 GSps @ Fout = 100 MHz 0 dBFS Fs = 3 GSps @ Fout = 700 MHz - 0 dBFS Fs = 3 GSps @ Fout = 700 MHz - 0 dBFS -70 -62 -67 -57 -57 1.6 Fs = 3 GSps @ Fout = 700 MHz - 0 dBFS -70 -62 -57 -57 1.6 Fs = 1 GSps @ Fout = 700 MHz - 0 dBFS -70 -62 -57 -62 1.6 SFD sensitivity & high spur level variation over power supplies 12 dB 4 4 Signal independent Spur (clock-related spur) Fc -68 -53 dBm 4 Fc/2 -80 dBm 4 4 Fc/4 -80 -40 dBm 4 DAC self noise density at code 0 or 4095 -140 -140 dBm/Hz 1.6 Fs = 3 GSps OMHz to codend pattern, 25 50.2 S0.2 dB (2) 1.6 DAC self noise density at code 0 or 4095 SNR 56.5 61.2 dB (2) 1.6 <	Highest spur level					dBm		
Fs = 3 GSps @ Fout = 700 MHz 0 dBFS Fs = 3 GSps @ Fout = 700 MHz 0 dBFS Fs = 1.5 GSps @ Fout = 700 MHz 0 dBFS 1.6 Fs = 3 GSps @ Fout = 700 MHz 0 dBFS Fs = 1.5 GSps @ Fout = 700 MHz 0 dBFS 1.8 SFDR sensitivity & high spur level variation over power supplies 1.2 0 0 4 Signal independent Spur (clock-related spur) Fc 1.8 1.8 1.6 4 Fo/4 1.8 -29 0 0 4 4 DAC self noise density at code 0 or 4095 1.8 -4 4 4 DAC self noise density at code 0 or 4095 1.8 -149 -143 0 1.6 Noise Power Ratio -14 dBFS peak to rms loading factor Fs = 3 GSps Computed from NPR figure at 3 GSps ENOB 9.1 9.9 Bit (2) 1.6 Signal to Noise Ratio Computed from NPR figure at 3 GSps SNR 56.5 61.2 dB (2) 1.6 Noise Power Ratio -14 dBFS peak to rms loading factor Fs = 3 GSps SNR 56.5 61.2 dB (2) 1.6 Signal to Noise Ratio Computed from NPR figure at 3 GSps SNR 56.5 61.2 dB (2) 1.6 Noise Power Ratio	MŬX4:1							
Fs = 3 GSps @ Fout = 1800 MHz 0 dBFS Fs = 3 GSps @ Fout = 700 MHz - 3 dBFS 1.6 1.6 SF = 1.5 GSps @ Fout = 700 MHz 0 dBFS -70 -62 -53 1.6 SFD R sensitivity & high spur level variation over power supplies 12 dB 4 Signal independent Spur (clock-related spur) Fc -29 -80 -80 dBm 4 Fc/2 -67 -140 -80 dBm 4 Fc/2 -80 -80 dBm 4 Fc/2 -80 dBm 4 Fc/4 -80 -40 dBm 4 DAC self noise density at code 0 or 4095 -140 -140 dBm/Lz 1.6 Noise Power Ratio -14 dBFS peak to rms loading factor Fs = 3 GSps 50.2 S0.2 dB (2) 1.6 Signal to Noise Ratio Computed from NPR figure at 3 GSps SNR 56.5 61.2 dB (2) 1.6	Fs = 3 GSps @ Fout = 100 MHz 0 dBFS			-70	-62			1,6
Fs = 3 GSps @ Fout = 700 MHz -3 dBFS Image: SFD Resentitivity & high spur level variation over power supplies Image: SFD Resentitivity & high spur level variation over power supplies Image: SFD Resentitivity & high spur level variation over power supplies Image: SFD Resentitivity & high spur level variation over power supplies Image: SFD Resentitivity & high spur level variation over power supplies Image: SFD Resentitivity & high spur level variation over power supplies Image: SFD Resentitivity & high spur level variation over power supplies Image: SFD Resentitivity & high spur level variation over power supplies Image: SFD Resentitivity & high spur level variation over power supplies Image: SFD Resentitivity & high spur level variation over power supplies Image: SFD Resentitivity & high spur level variation over power supplies Image: SFD Resentitivity & high spur level variation over power supplies Image: SFD Resentitivity & high spur level variation over power supplies Image: SFD Resentitivity & high spur level variation over power supplies Image: SFD Resentitivity & high spur level variation over power supplies Image: SFD Resentitivity & high spur level variation over power supplies Image: SFD Resentitivity & high spur level variation over power supplies Image: SFD Resentitivity & high spur level variation over power supplies Image: SFD Resentitivity & high spur level variation over power supplies Image: SFD Resentitivity & high spur level variation over power supplies Image: SFD Resentitivity & high spur level variation over power supplies Image: SFD Resentitivity & high spur level variation over power supplies Image: SFD Resentity & SFD	Fs = 3 GSps @ Fout = 700 MHz 0 dBFS			-64	-56			1,6
Fs = 3 GSps @ Fout = 700 MHz -3 dBFS Image: SFD Resentitivity & high spur level variation over power supplies Image: SFD Resentitivity & high spur level variation over power supplies Image: SFD Resentitivity & high spur level variation over power supplies Image: SFD Resentitivity & high spur level variation over power supplies Image: SFD Resentitivity & high spur level variation over power supplies Image: SFD Resentitivity & high spur level variation over power supplies Image: SFD Resentitivity & high spur level variation over power supplies Image: SFD Resentitivity & high spur level variation over power supplies Image: SFD Resentitivity & high spur level variation over power supplies Image: SFD Resentitivity & high spur level variation over power supplies Image: SFD Resentitivity & high spur level variation over power supplies Image: SFD Resentitivity & high spur level variation over power supplies Image: SFD Resentitivity & high spur level variation over power supplies Image: SFD Resentitivity & high spur level variation over power supplies Image: SFD Resentitivity & high spur level variation over power supplies Image: SFD Resentitivity & high spur level variation over power supplies Image: SFD Resentitivity & high spur level variation over power supplies Image: SFD Resentitivity & high spur level variation over power supplies Image: SFD Resentitivity & high spur level variation over power supplies Image: SFD Resentitivity & high spur level variation over power supplies Image: SFD Resentitivity & high spur level variation over power supplies Image: SFD Resentitivity & high spur level variation over power supplies Image: SFD Resentity & SFD				-67	-57			
MUX2:1 Fs = 1.5 GSps @ Fout = 700 MHz 0 dBFS Image: 1.6 Fs = 1.5 GSps @ Fout = 700 MHz 0 dBFS Image: 1.6 Fs = 1.5 GSps @ Fout = 700 MHz 0 dBFS Image: 1.6 Fs = 1.6 GSP & -53 Image: 1.6 Fs = 1.6 GSP & -43 Image: 1.6 Fs = 1.6 GSP & -44 Image: 1.6 FS = 1.6 GSP & -144 Image: 1.6 FS = 1.6 GSP & -1								
Fs = 1.5 GSps @ Fout = 700 MHz 0 dBFS Image: Method of the sector o				-70	-62			16
SFDR sensitivity & high spur level variation over power supplies±2dB4Signal independent Spur (clock-related spur) Fc Fc/2-29dBmdBm4Fc/2-29dBmdBm4Fc/2-80dBm44Fc/2-80dBm1.6Fc/2-80dBm1.6DAC self noise density at code 0 or 4095-149-149-143dBm/Hz1.6Noise Power Ratio -14 dBFS peak to rms loading factor Fs = 3 GSpsNPR45.550.2dB(2)1.6Q MHz to 900 MHz broadband pattern, 25 MHz notch centered on 450 MHzENOB9.19.9Bit(2)1.6Signal to Noise Ratio Computed from NPR figure at 3 GSpsSNR56.561.2dB(2)1.6Noise Power Ratio Computed from NPR figure at 3 GSpsNPRS5.7dB(2)1.6Noise Power Ratio Computed from NPR figure at 3 GSpsSNR56.561.2dB(2)1.6Noise Power Ratio Computed from NPR figure at 3 GSpsNPRS5.7dB(2)4Noise Power Ratio Computed from NPR figure at 3 GSpsNPR55.7dB(2)4Noise Power Ratio Computed from NPR figure at 3 GSpsNPRS5.7dB(2)4Signal to Noise Ratio Computed from NPR figure at 1.5 GSpsENOB10.8Bit(2)4Signal to Noise RatioSNR66.7dB(2)4				-				
Signal independent Spur (clock-related spur) Fc Fc/2Image: Signal independent Spur (clock-related spur) Fc Fc/2Image: Signal independent Spur (clock-related spur) Fc Fc/4Image: Signal independent Spur (clock-related spur) Fc Fc/4Image: Signal independent Spur (clock-related spur) Fc Fc Fc/4Image: Signal independent Spur (clock-related spur) Fc Fc Fc/4Image: Signal independent Spur (clock-related spur) Fc Fc Fc/4Image: Signal independent Spur (clock-related spur) Fc Fc Fc Fc/4Image: Signal independent Spur (clock-related spur) Fc Fc Fc Fc Fc/4Image: Signal independent Spur (clock-related spur) Fc				-00	-00			1,0
Fc Fc/2-29 -80dBm dBm4 4Fc/2Fc/2Image: Section of the section	SFDR sensitivity & high spur level variation over power supplies			±2		dB		4
Fc/2Image: Image: I	Signal independent Spur (clock-related spur)							
Fc/4-80dBm4DAC self noise density at code 0 or 4095-140-149-143dBm/Hz1,6Noise Power Ratio -14 dBFS peak to rms loading factor Fs = 3 GSps 20 MHz to 900 MHz broadband pattern, 25 MHz notch centered on 450 MHzNPR 45.5 50.2 JdB (2) $1,6$ Equivalent ENOB Computed from NPR figure at 3 GSpsENOB 9.1 9.9 Bit (2) $1,6$ Signal to Noise Ratio -14 dBFS peak to rms loading factor Fs = 1.5 GSpsSNR 56.5 61.2 dB (2) $1,6$ Noise Power Ratio -14 dBFS peak to rms loading factor Fs = 1.5 GSpsNPR 55.7 dB (2) $1,6$ Noise Power Ratio -14 dBFS peak to rms loading factor Fs = 1.5 GSpsNPR 55.7 dB (2) 4 Noise Power Ratio -14 dBFS peak to rms loading factor Fs = 1.5 GSpsNPR 55.7 dB (2) 4 Noise Power Ratio -14 dBFS peak to rms loading factor Fs = 1.5 GSpsENOB 10.8 Bit (2) 4 Equivalent ENOB Computed from NPR figure at 1.5 GSpsENOB 10.8 10.8 Bit (2) 4	Fc			-29		dBm		4
ACImage: Constraint of the state	Fc/2			-80		dBm		4
Noise Power Ratio -14 dBFS peak to rms loading factor Fs = 3 GSps 20 MHz to 900 MHz broadband pattern, 25 MHz notch centered on 450 MHzNPR45.550.2dB(2)1,6Equivalent ENOB Computed from NPR figure at 3 GSpsENOB9.19.9Bit(2)1,6Signal to Noise Ratio Computed from NPR figure at 3 GSpsSNR56.561.2dB(2)1,6Noise Power Ratio Computed from NPR figure at 3 GSpsNPR55.7dB(2)1,6Noise Power Ratio Computed from NPR figure at 3 GSpsNPR55.7dB(2)4Noise Power Ratio -14 dBFS peak to rms loading factor Fs = 1.5 GSpsNPR55.7dB(2)4Equivalent ENOB Computed from NPR figure at 1.5 GSpsENOB10.8Bit(2)4Signal to Noise Ratio Computed from NPR figure at 1.5 GSpsSNR66.7dB(2)4	Fc/4			-80		dBm		4
-14 dBFS peak to ms loading factor Fs = 3 GSps 20 MHz to 900 MHz broadband pattern, 25 MHz notch centered on 450 MHzENOB9.19.9Bit(2)1,6Equivalent ENOB Computed from NPR figure at 3 GSpsENOB9.19.9Bit(2)1,6Signal to Noise Ratio Computed from NPR figure at 3 GSpsSNR56.561.2dB(2)1,6Noise Power Ratio -14 dBFS peak to rms loading factor Fs = 1.5 GSps 10 MHz to 450 MHzNPRSSR55.7dB(2)4Equivalent ENOB Computed from NPR figure at 1.5 GSpsENOB10.8Bit(2)4Equivalent ENOB Computed from NPR figure at 1.5 GSpsSNR66.7dB(2)4	DAC self noise density at code 0 or 4095			-149	-143	dBm/Hz		1,6
-14 dBFS peak to ms loading factor Fs = 3 GSps 20 MHz to 900 MHz broadband pattern, 25 MHz notch centered on 450 MHzENOB9.19.9Bit(2)1,6Equivalent ENOB Computed from NPR figure at 3 GSpsENOB9.19.9Bit(2)1,6Signal to Noise Ratio Computed from NPR figure at 3 GSpsSNR56.561.2dB(2)1,6Noise Power Ratio -14 dBFS peak to rms loading factor Fs = 1.5 GSps 10 MHz to 450 MHzNPRSSR55.7dB(2)4Equivalent ENOB Computed from NPR figure at 1.5 GSpsENOB10.8Bit(2)4Equivalent ENOB Computed from NPR figure at 1.5 GSpsSNR66.7dB(2)4	Noise Power Potio		15 F	50.2		dP	(2)	1.6
Fs = 3 GSps 20 MHz to 900 MHz broadband pattern, 25 MHz notch centered on 450 MHzENOBSNR9.19.9Bit(2)1,6Equivalent ENOB Computed from NPR figure at 3 GSpsSNR56.561.2dB(2)1,6Signal to Noise Ratio Computed from NPR figure at 3 GSpsSNR56.561.2dB(2)1,6Noise Power Ratio -14 dBFS peak to rms loading factor Fs = 1.5 GSps 10 MHz to 450 MHz broadband pattern, 12.5 MHz notch centered on 225 MHzNPR55.7dB(2)4Equivalent ENOB Computed from NPR figure at 1.5 GSpsENOB10.8Bit(2)4		INFR	45.5	50.2		uБ	(2)	1,0
20 MHz to 900 MHz broadband pattern, 25 MHz notch centered on 450 MHzENOBImage: Simple state in the image: Simple stat								
25 MHz notch centered on 450 MHzImage: MHz notch centered on 225 MHzImage: MH								
Equivalent ENOB Computed from NPR figure at 3 GSpsENOBP.19.9Bit(2)1,6Signal to Noise Ratio Computed from NPR figure at 3 GSpsSNR56.561.2dB(2)1,6Noise Power Ratio -14 dBFS peak to rms loading factor Fs = 1.5 GSps 10 MHz to 450 MHz broadband pattern, 12.5 MHz notch centered on 225 MHzNPRSNR55.7dB(2)4Equivalent ENOB Computed from NPR figure at 1.5 GSpsENOBIn10.8Bit(2)4	· · · · · · · · · · · · · · · · · · ·							
Computed from NPR figure at 3 GSpsSNR56.561.2dB(2)1,6Signal to Noise Ratio Computed from NPR figure at 3 GSpsSNR56.561.2dB(2)1,6Noise Power Ratio -14 dBFS peak to rms loading factor Fs = 1.5 GSps 10 MHz to 450 MHz broadband pattern, 12.5 MHz notch centered on 225 MHzNPRS5.7dB(2)4Equivalent ENOB Computed from NPR figure at 1.5 GSpsENOB10.8Bit(2)4Signal to Noise RatioSNR66.7dB(2)4	25 MHz notch centered on 450 MHz							
Computed from NPR figure at 3 GSpsSNR56.561.2dB(2)1,6Signal to Noise Ratio Computed from NPR figure at 3 GSpsSNR56.561.2dB(2)1,6Noise Power Ratio -14 dBFS peak to rms loading factor Fs = 1.5 GSps 10 MHz to 450 MHz broadband pattern, 12.5 MHz notch centered on 225 MHzNPRS5.7dB(2)4Equivalent ENOB Computed from NPR figure at 1.5 GSpsENOB10.8Bit(2)4Signal to Noise RatioSNR66.7dB(2)4	Equivalent ENOB	ENOB	91	99		Bit	(2)	16
Computed from NPR figure at 3 GSpsNPRS5.7dB(2)4Noise Power Ratio -14 dBFS peak to rms loading factor Fs = 1.5 GSps 10 MHz to 450 MHz broadband pattern, 12.5 MHz notch centered on 225 MHzNPR55.7dB(2)4Equivalent ENOB Computed from NPR figure at 1.5 GSpsENOB10.8Bit(2)4Signal to Noise RatioSNR66.7dB(2)4	•	LINOD	0.1	0.0		Dit	(2)	1,0
Computed from NPR figure at 3 GSpsNPRS5.7dB(2)4Noise Power Ratio -14 dBFS peak to rms loading factor Fs = 1.5 GSps 10 MHz to 450 MHz broadband pattern, 12.5 MHz notch centered on 225 MHzNPR55.7dB(2)4Equivalent ENOB Computed from NPR figure at 1.5 GSpsENOB10.8Bit(2)4Signal to Noise RatioSNR66.7dB(2)4	Signal to Noise Ratio	SNR	56.5	61.2		dB	(2)	16
-14 dBFS peak to rms loading factor Fs = 1.5 GSps 10 MHz to 450 MHz broadband pattern, 12.5 MHz notch centered on 225 MHzENOBImage: Compute of the second secon		ONIX	00.0	01.2		db	(2)	1,0
-14 dBFS peak to rms loading factor Fs = 1.5 GSps 10 MHz to 450 MHz broadband pattern, 12.5 MHz notch centered on 225 MHzENOBImage: Compute of the second secon	Noise Power Ratio	NPR		55.7		dB	(2)	4
Fs = 1.5 GSps 10 MHz to 450 MHz broadband pattern, 12.5 MHz notch centered on 225 MHzENOBImage: Signal to Noise RatioBit(2)4Signal to Noise RatioSNR66.7dB(2)4				00.1			(-)	.
10 MHz to 450 MHz broadband pattern, 12.5 MHz notch centered on 225 MHzENOBImage: Second centered on 225 MHzImage: Second centered on 225 MHzEquivalent ENOB Computed from NPR figure at 1.5 GSpsENOB10.8Bit(2)4Signal to Noise RatioSNR66.7dB(2)4								
12.5 MHz notch centered on 225 MHzImage: Section of the								
Equivalent ENOB Computed from NPR figure at 1.5 GSpsENOBIO.8Bit(2)4Signal to Noise RatioSNR66.7dB(2)4								
Computed from NPR figure at 1.5 GSps SNR 66.7 dB (2) 4	12.5 MHz notch centered on 225 MHz							
Computed from NPR figure at 1.5 GSps SNR 66.7 dB (2) 4		ENOR		10.8		Bit	(2)	Δ
Signal to Noise Ratio SNR 66.7 dB (2) 4		LINOD	1	10.0		Dit	(2)	7
	Computed from MER lighter at 1.5 Gops							
	Signal to Noise Ratio	SNR		66.7		dB	(2)	4
Computed from NPR figure at 1.5 GSps		-					` '	

Notes:

2. Figures in tables are derived from industrial screening; for practical reasons (necessity to cover also 2nd and 3rd Nyquist Zones) the balun used for industrial test is not optimum for first Nyquist performances, and results when Fout or folded low order hamonics are between DC to 400 MHz are very pessimistic. For further details please refer to Section 7.2 on page 38 for effect of the balun on performances.

^{1.} See Section 3.6 on page 13 for explanation of test levels.

Parameter	Symbol	Min	Тур	Мах	Unit	Note	Test level ⁽¹⁾
Single-tone Spurious Free Dynamic Range MUX4:1 Fs = 3 GSps @ Fout = 1600 MHz 0 dBFS Fs = 3 GSps @ Fout = 2900 MHz 0 dBFS	SFDR	49	60 57		dBc		4 1,6
Highest spur level MUX4:1 Fs = 3 GSps @ Fout =1600 MHz 0 dBFS Fs = 3 GSps @ Fout = 2900 MHz 0 dBFS			67 66	-59	dBm		4 1,6
SFDR sensitivity & high spur level variation over power supplies			±2		dB		4
Signal independent Spur (clock-related spur) Fc			-25		dBm		4
Fc/2			-80		dBm		4
Fc/4			-80		dBm		4
DAC self noise density at code 0 or 4095			-143	-139	dBm/Hz		1,6
Noise Power Ratio –14 dBFS peak to rms loading factor Fs = 3 GSps 1520 MHz to 2200 MHz broadband pattern, 25 MHz notch centered on 1850 MHz	NPR	39.5	44.0		dB		1,6
Equivalent ENOB Computed from NPR figure at 3 GSps	ENOB	8.1	8.8		Bit		1,6
Signal to Noise Ratio Computed from NPR figure at 3 GSps	SNR	50.5	55.0		dB		1,6

Table 3-6. AC Electrical Characteristics RTZ Mode (Second Nyquist Zone)(2)

Notes:

1. See Section 3.6 on page 13 for explanation of test levels.

2. Please refer to Section 7.2 "AC Performances" on page 38 to have detailed characterization results.

Table 3-7. AC Electrical Characteristics RF Mode (Second and Third Nyquist Zones)⁽²⁾

Parameter	Symbol	Min	Тур	Мах	Unit	Note	Test level ⁽¹⁾
Single-tone Spurious Free Dynamic Range 2 nd Nyquist Fs = 3 GSps @ Fout = 1600 MHz 0 dBFS Fs = 3 GSps @ Fout = 2900 MHz 0 dBFS 3 rd Nyquist	SFDR	44	52 60		dBc		1,6 4
Fs = 3 GSps @ Fout = 3800 MHz		45 45	53 54				1,6 1,6
Highest spur level 2^{nd} Nyquist Fs = 3 GSps @ Fout = 1600 MHz 0 dBFS Fs = 3 GSps @ Fout = 2900 MHz 0 dBFS 3^{rd} Nyquist Fs = 3 GSps @ Fout = 3800 MHz 0 dBFS			-58 -58 -60	-50 -52	dBm		1,6 4 1,6
Fs = 3 GSps @ Fout = 4400 MHz 0 dBFS			-62	-55			1,6
SFDR sensitivity & high spur level variation over power supplies			±2		dB		4
Signal independent Spur (clock-related spur) Fc Fc/2 Fc/4			-28 -80 -80		dBm dBm dBm		4 4 4
DAC self noise density at code 0 or 4095			-141	-138	dBm/Hz		1,6
Noise Power Ratio (2 nd Nyquist) –14 dBFS peak to rms loading factor Fs = 3 GSps 1520 MHz to 2200 MHz broadband pattern, 25 MHz notch centered on 1850 MHz	NPR	38	42		dB		1,6
Equivalent ENOB Computed from NPR figure at 3 GSps	ENOB	7.8	8.5		Bit		1,6
Signal to Noise Ratio Computed from NPR figure at 3 GSps	SNR	49	53		dB		1,6
Noise Power Ratio –14 dBFS peak to rms loading factor Fs = 3 GSps 2200 MHz to 2880 MHz broadband pattern, 25 MHz notch centered on 2550 MHz	NPR	38	42		dB		1,6
Equivalent ENOB Computed from NPR figure at 3 GSps	ENOB	7.8	8.5		Bit		1,6
Signal to Noise Ratio Computed from NPR figure at 3 GSps	SNR	49	53		dB		1,6
Noise Power Ratio –14 dBFS peak to rms loading factor Fs = 3 GSps 3050 MHz to 3700 MHz broadband pattern, 25 MHz notch centered on 3375 MHz	NPR	38	40		dB	(2)	1,6
Equivalent ENOB Computed from NPR figure at 3 GSps	ENOB	7.8	8.2		Bit	(2)	1,6
Signal to Noise Ratio Computed from NPR figure at 3 GSps	SNR	49	51		dB	(2)	1,6

Notes:

1. See Section 3.6 on page 13 for explanation of test levels.

 Figures in tables are derived from industrial screening without any correction to take in account the balun effect, but for practical reasons (necessity to cover also 2nd and 3rd Nyquist Zones) the balun used for industrial test is not optimum for first Nyquist performances, and results when Fout or folded low order hamonics are between DC to 400 MHz are very pessimistic.

3.5 Timing Characteristics and Switching Performances

Table 3-8. Timing Characteristics and Switching Performances

Parameter	Symbol	Min	Тур	Max	Unit	Note	Test level ⁽¹⁾
SWITCHING PERFORMANCE AND CHARACTERIS	STICS	<u> </u>		1		1	
Operating clock frequency 4:1 MUX mode 2:1 MUX mode		300 300		3000 1500	MHz		4
TIMING CHARACTERISTICS							
Analog output rise/fall time	T _{or} T _{of}		60		ps	(2)	4
Data Tsetup (Fc = 3 Gsps)		250			ps	(3)	4
Data Thold (Fc = 3 Gsps)		100			ps	(3)	4
Max Input data rate (Mux 4:1)		75		750	MSps		4
Max Input data rate (Mux 2:1)		150		750	MSps		4
Master clock input jitter				100	fs rms	(4)	5
DSP clock phase tuning steps			0.5		Clock period		5
Master clock to DSP, DSPN delay	TDSP		1.6		ns		4
SYNC forbidden area lower bound (Fc = 3 Gsps)	T ₁		350		ps	(5)(6)	4
SYNC forbidden area upper bound (Fc = 3 Gsps)	T ₂		330		ps	(5)(6)	4
SYNC to DSP, DSPN MUX 2:1 MUX4:1			880 1600		ps		4
Data Pipeline Delay MUX4:1 MUX2:1	TPD		3.5 3.5		Clock period		4
Data Output Delay	TOD		160		ps		4

Notes:

1. See Section 3.6 on page 13 for explanation of the test level.

- 2. Analog output rise/fall time measured from 20% to 80% of a full scale jump, after probe de-embedding.
- 3. Exclusive of period (pp) jitter on Data. Setup and hold time for DATA at input relative to DSP clock at output of the component, at PSS = 000; also applicable for IDC signal.
- 4. Master clock input jitter defined over 5 GHz bandwidth.
- 5. The SYNC signal is captured on the falling edge of the master clock and is active high. Refer to Figure 3-3.
- 6. For EV12DS130A, please refer to erratasheet 1125



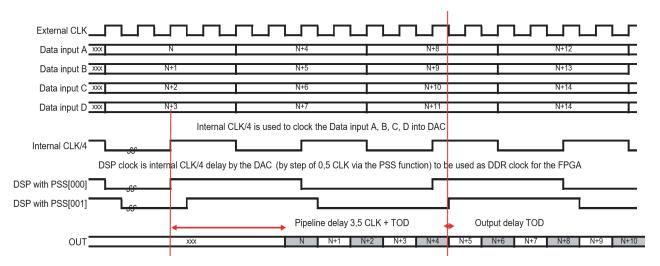


Figure 3-2. Timing Diagram for 2:1 MUX Principle of Operation OCDS[00]

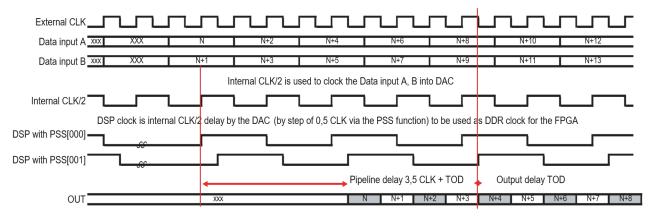
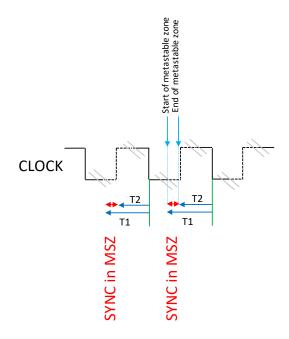


Figure 3-3. SYNC Timing Diagram



MSZ = Metastable zone

Please refer to Section 5.9 "Synchronization functions for multi-DAC operation" on page 28.

3.6 Explanation of Test Levels

100% production tested at +25°C ⁽¹⁾
100% production tested at +25°C ⁽¹⁾ , and sample tested at specified temperatures.
Sample tested only at specified temperatures
Parameter is guaranteed by design and/or characterization testing (thermal steady-state conditions at specified temperature)
Parameter value is guaranteed by design
100% production tested over specified temperature range (for Space/Mil grade ⁽²⁾)
-

Only MIN and MAX values are guaranteed.

Notes:

- 1. Unless otherwise specified.
- 2. If applicable, please refer to "Ordering Information"

3.7 Digital Input Coding Table

Table 3-9. Coding Table (Theorical values)

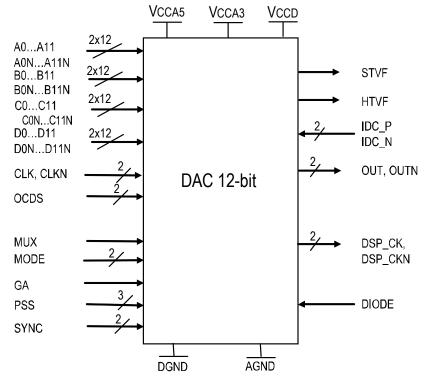
Digital output msbIsb	Differential analog output
0000000000	–500 mV
0100000000	–250 mV
01100000000	–125 mV
01111111111	–0.122 mV
1000000000	0.122 mV
10100000000	+125 mV
11000000000	+250 mV
1111111111	+500 mV

4. DEFINITION OF TERMS

Abbreviation	Term	Definition						
(Fs max)	Maximum conversion Frequency	Maximum conversion frequency						
(Fs min)	Minimum conversion frequency	Minimum conversion Frequency						
(SFDR)	Spurious free dynamic range	Ratio expressed in dB of the RMS signal amplitude, set at Full Scale, to the RMS value of the highest spectral component (peak spurious spectral component). The peak spurious component may or may not be a harmonic. It may be reported in dB (i.e., related to converter 0 dB Full Scale), or in dBc (i.e., related to input signal level).						
(HSL)	High Spur Level	Power of highest spurious spectral component expressed in dBm.						
(ENOB)	Effective Number Of Bits	ENOB is determinated from NPR measurement with the formula: ENOB = $(NPR_{[dB]} + ILF_{[dB]}I - 3 - 1.76) / 6.02$ Where LF "Loading factor" is the ratio between the Gaussian noise standard deviation versus amplitude full scale.						
(SNR)	Signal to noise ratio	SNR is determinated from NPR measurement with the formula: SNR[dB] = NPR[dB] + ILF[dB]I – 3 Where LF "Loading factor" is the ratio between the Gaussian noise standard deviation versus amplitude full scale.						
(DNL)	Differential non linearity	The Differential Non Linearity for an given code i is the difference between the measured stern size of code i and the ideal LSB step size. DNL (i) is expressed in LSBs. DNL is the maximut value of all DNL (i). DNL error specification of less than 1 LSB guarantees that there are no missing point and that the transfer function is monotonic.						
(INL)	Integral non linearity	The Integral Non Linearity for a given code i is the difference between the measured voltage at which the transition occurs and the ideal value of this transition. INL (i) is expressed in LSBs, and is the maximum value of all INL (i)						
(TPD/TOD)	Output delay	The analog output propagation delay measured between the rising edge of the differential CLK, CLKN clock input (zero crossing point) and the zero crossing point of a full-scale analog output voltage step. TPD corresponds to the pipeline delay plus an internal propagation delay (TOD) including package access propagation delay and internal (on-chip) delays such as clock input buffers and DAC conversion time.						
(NPR)	Noise Power Ratio	The NPR is measured to characterize the DAC performance in response to broad bandwidth signals. When applying a notch-filtered broadband white-noise pattern at the input to the DAC under test, the Noise Power Ratio is defined as the ratio of the average noise measured on the shoulder of the notch and inside the notch on the same integration bandwidth.						
(VSWR)	Voltage Standing Wave Ratio	The VSWR corresponds to the insertion loss linked to power reflection. For example a VSWR of 1:2 corresponds to a 20dB return loss (ie. 99% power transmitted and 1% reflected).						
(IUCM)	Input under clocking mode	The IUCM principle is to apply a selectable division ratio between DAC section clock and the MUX section clock.						
(PSS)	Phase Shift Select	The Phase Shift Select function allow to tune the phase of the DSPclock.						
(OCDS)	Output Clock Division Selectt	It allows to divide the DSPclock frequency by the OCDS coded value factor						
(NRZ)	Non Return to Zero mode	Non Return to Zero mode on analog output						
(RF)	Radio Frequency mode	RF mode on analog output						
(RTZ)	Return to zero	Return to zero mode on analog output						
(NRTZ)	Narrow return to zero	Narrow return to zero mode on analog output						

5. FUNCTIONAL DESCRIPTION

Figure 5-1. DAC Functional Diagram



Name	Function	Name	Function
V _{CCD}	3.3V Digital Power Supply	CLK	In-phase Master clock
V _{CCA5}	5.0V Analog Power Supply	CLKN	Inverted phase Master clock
V _{CCA3}	3.3V Analog Power Supply	DSP_CK	In-phase Output clock
DGND	Digital Ground	DSP_CKN	Inverted phase Output clock
AGND	Analog ground (for analog supply reference)	PSS[02]	Phase shift select
A[110]	In-phase digital input Port A	GA	Gain Adjust
A[110]N	Inverted phase digital input Port A	MUX	Multiplexer Selection
B[110]	In-phase digital input Port B	MODE[01]	DAC Mode: NRZ, RTZ, NRTZ, RF
B[110]N	Inverted phase digital input Port B	STVF	Setup time Violation flag
C[110]	In-phase digital input Port C	HTVF	Hold time Violation flag
C[110]N	Inverted phase digital input Port C	IDC_P, IDC_N	Input data check
D[110]	In-phase digital input Port D	OCDS[01]	Output Clock Division factor Selection
D[110]N	Inverted phase digital input Port D	Diode	Diode for temperature monitoring
OUT	In-phase analog output	SYNC/SYNCN	Synchronization signal (Active High)
OUTN	Inverted phase analog output	IUCM	Input UnderClocking Mode

5.1 DSP Output Clock

The DSP output clock DSP, DSPN is an LVDS signal which is used to synchronize the FPGA generating the digital patterns with the DAC sampling clock.

The DSP clock frequency is a fraction of the sampling clock frequency. The division factor depends on OCDS settings. The DSP clock frequency is equal to (sampling frequency / [2N*X]) where N is the MUX ratio and X is the output clock division factor, determined by OCDS[0..1] bits.

For example, in a 4:1 MUX ratio application with a sampling clock of 3 GHz and OCDS set to "00" (ie. Factor of 1), the input data rate is 750 MSps and the DSP clock frequency is 375 MHz.

This DSP clock is used in the FPGA to control the digital data sequencing. Its phase can be adjusted using the PSS[2:0] bits (refer to Section 5.5 on page 23) in order to ensure a proper synchronization between the data coming to the DAC and the sampling clock.

The HTVF and STVF bits should be used to check whether the timing between the FPGA and the DAC is correct. HTVF and STVF bits will indicate whether the DAC and FPGA are aligned or not. PSS bits should then be used to shift the DSP clock and thus the input data of the DAC, so that a correct timing is achieved between the FPGA and the DAC.

Important note: Maximum supported sampling frequency when using DSP to clock digital data is 2.1 Gsps on EV12DS130B. Please refer to application note AN1141 to use EV12DS130B at sampling frequency beyond 2.1 GHz.

5.2 Multiplexer

Two multiplexer ratio are allowed:

- 4:1 which allows operation at full sampling rate (ie. 3 GHz)
- 2:1 which can only be used up to 1.5 GHz sampling rate, except in IUCM mode

Label	Value	Description
	0	4:1 mode
MUX	1	2:1 mode

In 2:1 MUX ratio, the unused data ports (ports C and D) can be left open.

5.3 MODE Function

Label	Value	Description	Default Setting (Not Connected)		
	00	NRZ mode			
	01	Narrow RTZ (a.k.a. NRTZ) mode	11		
MODE[1:0]	10	RTZ Mode (50%)	RF mode		
	11	RF mode			

The MODE function allows choosing between NRZ, NRTZ, RTZ and RF functions. NRZ and narrow RTZ should be chosen for use in 1st Nyquist zone while RTZ should be chosen for use in 2nd and RF for 3rd Nyquist zones.

Theory of operation: see following subsections for time domain waveform of the different modes.

Ideal equations describing max available Pout for frequency domain in the four modes are given hereafter, with X = normalized output frequency (that is Fout/Fclock, edges of Nyquist zones are then at X = 0.1/2 1.3/2 2...). Due to limited bandwidth, an extra term must be added to take in account a first order low pass filter.

NRZ mode:

Pout(X) = 20.
$$\log_{10} \cdot \left[\frac{|k. \operatorname{sinc}(k. \pi. X)|}{0.893} \right]$$

where sinc(x) = sin(x)/x, and k = 1

NRTZ mode:

$$Pout(X) = 20.\log_{10} \cdot \left[\frac{|k. sinc(k. \pi. X)|}{0.893} \right] \qquad \qquad k = \frac{Tclk - T\tau}{Tclk}$$

where $T\tau$ is width of reshaping pulse, $T\tau$ is about 75ps.

RTZ mode:

$$Pout(X) = 20.\log_{10} \cdot \left[\frac{|k. sinc(k. \pi. X)|}{0.893} \right]$$

where k is the duty cycle of the clock presented at the DAC input, please note that due to phase mismatch in balun used to convert single ended clock to differential clock the first zero may move around the limit of the 4^{th} and the 5^{th} Nyquist zones. Ideally k = 1/2.

RF mode:

$$Pout(X) = 20.\log_{10} \cdot \left[\frac{\left| k.\operatorname{sinc}\left(\frac{k.\pi.X}{2}\right) \cdot \sin\left(\frac{k.\pi.X}{2}\right) \right|}{0.893} \right]$$

where k is as per in NRTZ mode.

As a consequence:

- NRZ mode offers max power for 1st Nyquist operation
- RTZ mode offers slow roll off for 2nd Nyquist or 3rd Nyquist operation
- RF mode offers maximum power over 2nd and 3rd Nyquist operation
- NRTZ mode offers optimum power over full 1st and first half of 2nd Nyquist zones. This is the most relevant in term of performance for operation over 1st and beginning of 2nd Nyquist zone. Depending on the sampling rate the zero of transmission moves in the 3rd Nyquist zone from begin to end when sampling rate increases.

Note in the two following figures: Pink line is ideal equation's result, and green line includes a first order 6 GHz cut-off low pass filter to take into account finite bandwidth effect due to die and package.

Figure 5-2. Max Available Pout[dBm] at Nominal Gain vs Fout[GHz] in the Four Output Modes at 3 Gsps, over four Nyquist Zones, Computed for $T\tau$ = 75 ps

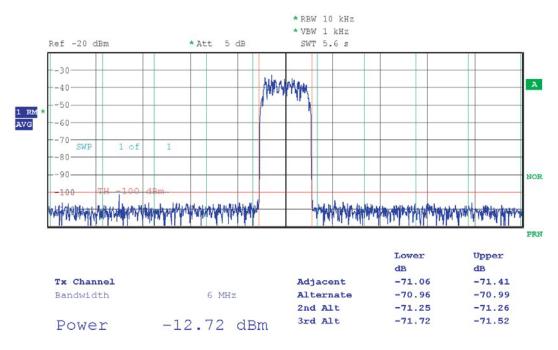
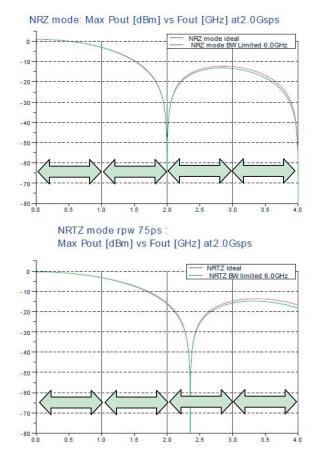
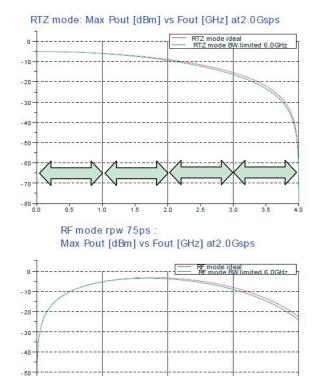


Figure 5-3. Max available Pout[dBm] at Nominal Gain vs Fout[GHz] in the Four Output Modes at 2 Gsps, over four Nyquist Zones, Computed for Tτ = 75 ps





An Important Notice at the end of this datasheet addresses availability, warranty, changes, use in critical applications, intellectual property matters and other important disclaimers

60

-70

- 80 -

0.0

0.5

1.0

2.5

2.0

3.5

4.0

3.0

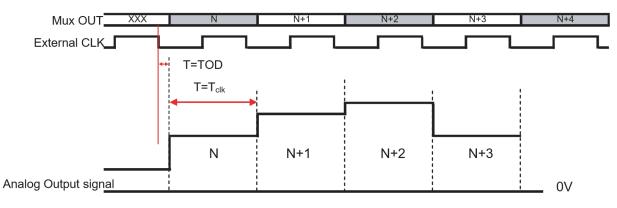
1.5

5.3.1 NRZ Output Mode

This mode does not allow for operation in the 2nd Nyquist zone because of the Sinx/x notch.

The advantage is that it gives good results at the beginning of the 1st Nyquist zone (less attenuation than in RTZ architecture), it removes the parasitic spur at the clock frequency (in differential).

Figure 5-4. NRZ Timing Diagram

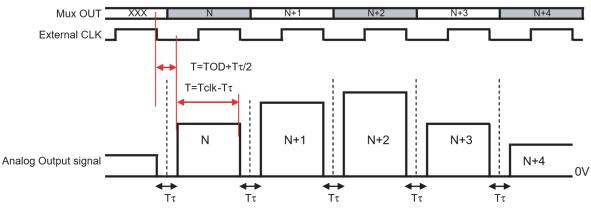


5.3.2 Narrow RTZ Mode (NRTZ Mode)

This mode has the following advantages:

- Optimized power in 1st Nyquist zone
- Extended dynamic through elimination of noise on transition edges
- Improved spectral purity (see Section 7.2.3 on page 45)
- Trade off between NRZ and RTZ

Figure 5-5. Narrow RTZ Timing Diagram



Note: $T\tau$ is independent of Fclock.

5.3.3 RTZ Mode

The advantage of the RTZ mode is to enable the operation in the 2nd zone but the drawback is clearly to attenuate more the signal in the first Nyquist zone.

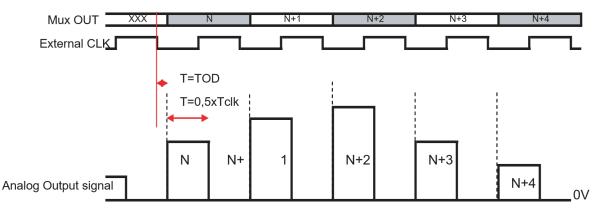
Advantages:

- Extended roll off of sinc
- Extended dynamic through elimination of hazardous transitions

Weakness:

• By construction clock spur at Fs.

Figure 5-6. RTZ Timing Diagram



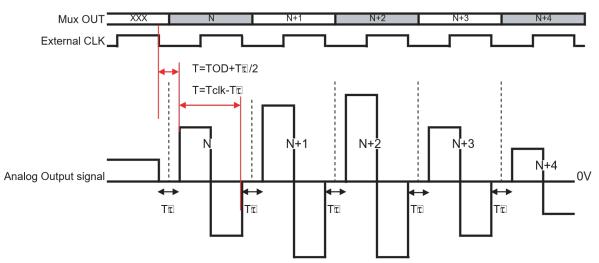
5.3.4 RF Mode

RF mode is optimal for operation at high output frequency, since the decay with frequency occurs at higher frequency than for RTZ. Unlike NRZ or RTZ modes, RF mode presents a notch at DC and 2N*Fs, and minimum attenuation for Fout = Fs.

Advantages:

- Optimized for 2nd and 3rd Nyquist operation
- Extended dynamic range through elimination of hazardous transitions.
- Clock spur pushed to 2.Fs

Figure 5-7. RF Timing Diagram



Note: The central transition is not hazardous but its elimination allows to push clock spur to 2.Fs Tτ is independent of Fclock.

5.4 Input Under Clocking Mode (IUCM), Principle and Spectral Response

An Input Under Clocking Mode has been added to the DAC in order to allow the DAC input data rate to be at half the nominal rate with respect of the DAC sampling rate.

When the under clocking mode is activated, the DAC expects data at half the nominal rate: if the DAC works at Fs sampling rate, then in 4:1 MUX mode, the input data rate should be Fs/4 and the DSP clock should be Fs/(2N*OCDS), with N = MUX ratio and OCDS = OCDS Ratio.

When the IUCM is active, the input data rate can be Fs/8 and the DSP clock frequency is Fs/(2N*OCDS*2), with N = MUX ratio and OCDS = OCDS Ratio. This means that in input under clocking mode, the DAC is capable to treat data at half the nominal rate. In this case, the DSP clock is also half its nominal speed.

Label	Logic Value	Description
	0	Input Under Clocking Mode inactive
IUCM	1	Input Under Clocking Mode active

To disable this mode, the IUCM pin must be connected to GND.

To enable this mode, IUCM must be connected to V_{CCD} or left unconnected The IUCM mode affects spectral response of the different modes.

The first effect is that Nyquist zone edges are not anymore at n*Fclock/2 but at n*/Fclock/4 (direct consequence of the division by 2 of the data rate).

The second effect is the modification of the equations ruling the spectral responses in the different modes.

Ideal equations describing max available Pout for frequency domain in the four output modes when IUCM mode is activated are given hereafter, with X= normalised output frequency (that is Fout/Fclock, edges of Nyquist Zones are then at X = 0, 1/4, 1/2, 3/4, 1, ...)

In fact due to limited bandwidth, an extra term must be added to take in account a first order low pass filter with a 6 GHz cut-off frequency.

NRZ mode:

Pout(X) = 20.
$$\log_{10} \left[\frac{|k. \operatorname{sinc}(k. \pi. X). \cos(\pi. X)|}{0.893} \right]$$

where sinc(x) = sin(x)/x, and k = 1

NRTZ mode:

$$Pout(X) = 20.\log_{10} \cdot \left[\frac{|k.\operatorname{sinc}(k. \pi. X). \cos(\pi. X)|}{0.893} \right] \qquad \qquad k = \frac{\operatorname{Tclk} - \operatorname{T\tau}}{\operatorname{Tclk}}$$

where $T\tau$ is width of reshaping pulse, $T\tau$ is about 75ps.

RTZ mode:

Pout(X) = 20. log₁₀.
$$\left[\frac{|k. sinc(k. \pi. X). cos(\pi. X)|}{0.893}\right]$$

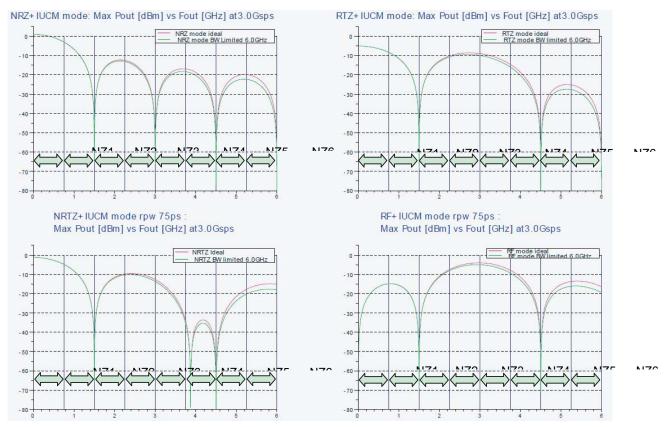
where k is the duty cycle of the clock presented at the DAC input, please note that due to phase mismatch in balun used to convert single ended clock to differential clock the first zero may move around the limit of the 4^{th} and the 5^{th} Nyquist zones. Ideally k = 1/2.

RF mode:

$$Pout(X) = 20.\log_{10} \cdot \left[\frac{\left| k. \operatorname{sinc} \left(\frac{k. \pi. X}{2} \right) \cdot \operatorname{sin} \left(\frac{k. \pi. X}{2} \right) \cdot \cos(\pi. X) \right|}{0.893} \right]$$

where k is as per in NRTZ mode.





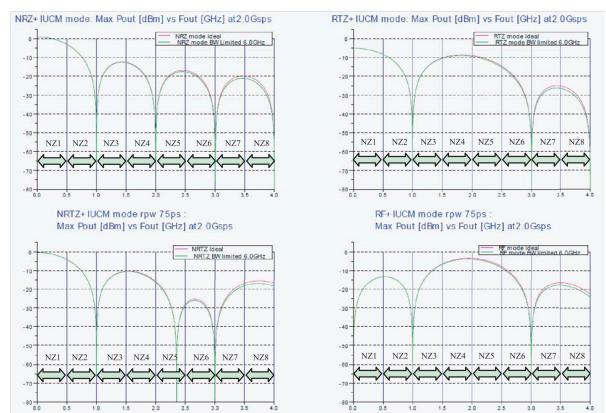


Figure 5-9. Max available Pout[dBm] at nominal gain vs Fout[GHz] in the four output modes at 2 GSps, combined with IUCM, over four nyquist zones, computed for $T\tau$ = 75 ps

5.5 PSS (Phase Shift Select Function)

It is possible to adjust the timings between the sampling clock and the DSP output clock (which frequency is given by the following formula: Sampling clock / 2NX where N is the MUX ratio, X the output clock division factor).

The DSP clock output phase can be tuned over a range of 3.5 input clock cycles (7 steps of half a clock cycle) in addition to the intrinsic propagation delay between the DSP clock (DSP, DSPN) and the sampling clock (CLK, CLKN).

Three bits are provided for the phase shift function: PSS[2:0].

By setting these 3 bits to 0 or 1, one can add a delay on the DSP clock in order to properly synchronize the input data of the DAC and the sampling clock (the DSP clock should be applied to the FPGA and should be used to clock the DAC digital input data).

Label	Value	Description					
	000	No additional delay on DSP clock					
	001	0.5 input clock cycle delay on DSP clock					
	010	1 input clock cycle delay on DSP clock					
	011	1.5 input clock cycle delay on DSP clock					
PSS[2:0]	100	2 input clock cycle delay on DSP clock					
	101	2.5 input clock cycle delay on DSP clock					
	110	3 input clock cycle delay on DSP clock					
	111	3.5 input clock cycle delay on DSP clock					

Table 5-2. PSS Coding Table

In order to determine how much delay needs to be added on the DSP clock to ensure the synchronization between the input data and the sampling clock within the DAC, the HTVF and STVF bits should be monitored. Refer to Section 5.7 on page 26.

Note: In MUX 4:1 mode the 8 settings are relevant, in MUX 2:1 only the four first settings are relevant since the four last ones will yield exactly the same results.

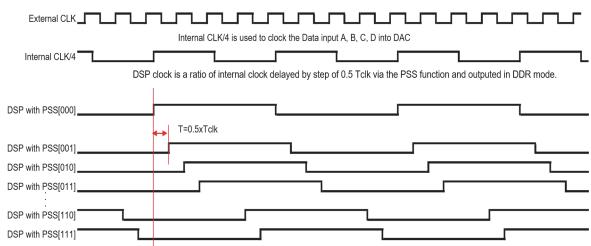
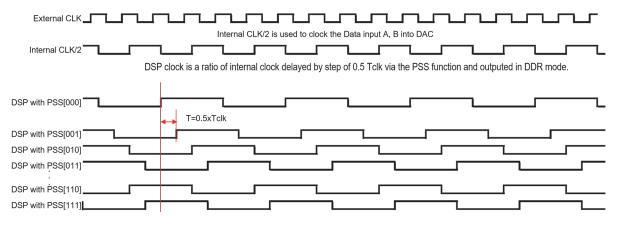


Figure 5-10. PSS Timing Diagram for 4:1 MUX, OCDS[00]

Figure 5-11. PSS Timing Diagram for 2:1 MUX, OCDS[00]



5.6 Output Clock Division Select Function

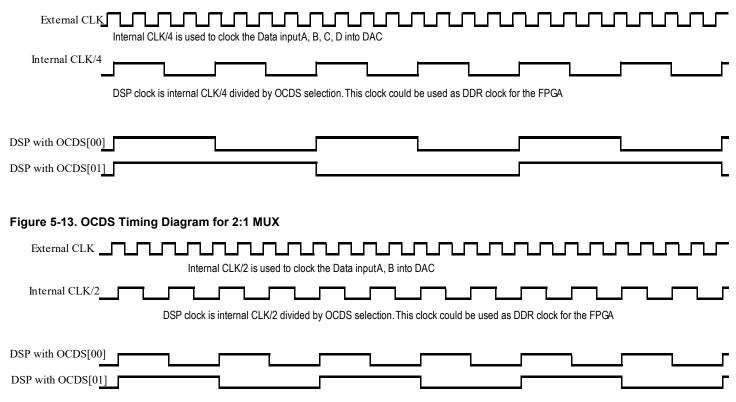
It is possible to change the DSP clock internal division factor from 1 to 2 with respect to the sampling clock/2N where N is the MUX ratio. This is possible via the OCDS "Output Clock Division Select" bits.

OCDS is used to obtain a synchronization clock for the FPGA slow enough to allow the FPGA to operate with no further internal division of this clock, thus its internal phase is determined by the DSP clock phase. This is useful in a system with multiple DACs and multiple FPGAs to guarantee deterministic phase relationship between the FPGAs after a synchronization of all the DACs.

Table 5-3. OCDS[1:0] Coding Table

Label	Value	Description							
	00	DSP clock frequency is equal to the sampling clock divided by 2N							
	01	DSP clock frequency is equal to the sampling clock divided by 2N*2							
OCDS [1:0]	10	Not allowed							
	11	Not allowed							

Figure 5-12. OCDS Timing Diagram for 4:1 MUX



5.7 Synchronization FPGA-DAC: IDC_P, IDC_N, HTVF and STVF Functions IDC_P, IDC_N: Input Data check function (LVDS signal).

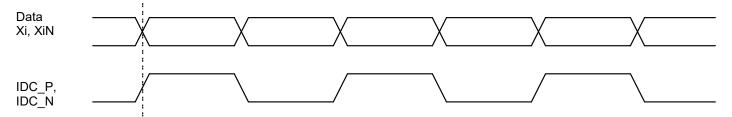
HTVF: Hold Time Violation Flag. (cmos3.3V signal)

STVF: Setup Time Violation Flag. (cmos3.3V signal)

IDC signal is toggling at each cycle synchronously with other data bits. It should be considered as a DAC input data that toggles at each cycle.

This signal should be generated by the FPGA in order for the DAC to check in real-time if the timings between the FPGA and the DAC are correct.

Figure 5-14. IDC Timing vs Data Input



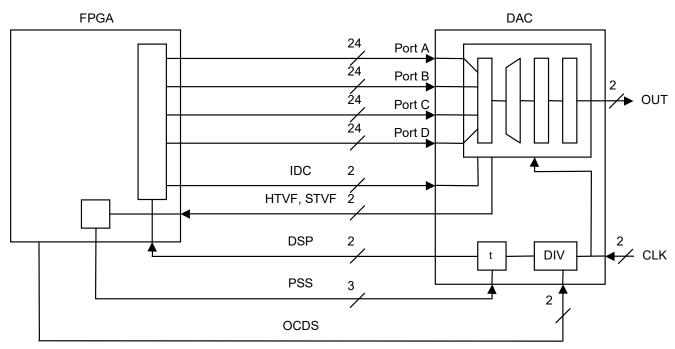
The information on the timings is then given by HTVF, STVF signals (flags).

Table 5-4. HTVF, STVF Coding Table

Label	Value	Description		
	0	SYNCHRO OK		
HTVF	1	Data Hold time violation detected		
	0	SYNCHRO OK		
STVF	1	Data Setup time violation detected		

During monitoring STVF indicates setup time of data violation (Low -> OK, High -> Violation), HTVF indicates hold time of data violation (Low -> OK, High -> Violation).

Figure 5-15. FPGA to DAC Synoptic



Principle of Operation:

The Input Data Check pair (IDC_P, IDC_N) will be sampled three times with half a master clock period shift (the second sample being synchronous with all the data sampling instant), these three samples will be compared, and depending on the results of the comparison a violation may be signalled.

- Violation of setup time -> STVF is high level
- Violation of hold time -> HTVF is high level

In case of violation of timing (setup or hold) the user has two solutions:

- Shift phase in the FPGA PLL (if this functionality is available in FPGA) for changing the internal timing of DATA and Data Check signal inside FPGA.
- Shift the DSP clock timing (Output clock of the DAC which can be used for FPGA synchronization refer to Section 5.5 on page 23), in this case this shift also shift the internal timing of FPGA clock.

Note: When used, it should be routed as the data signals (same layout rules and same length). if not used, it should be driven to an LVDS low or high level.

For further details, refer to application note AN1087.

5.8 OCDS, MUX Combinations Summary

MUX IU		IUCN	IUCM		S	PSS range	Data rate	Comments	
0		1 00 DSP clock division factor 16							
0		1	_	01	DSP clock division factor 32	0 to 7/(2Fs) by		Refer to Section	
0		1	ON	10	Not allowed	1/(2Fs) steps	Fs/8	5.6	
0		1	-	11	Not allowed	_			
0	4:1	0		00	DSP clock division factor 8				
0	-	0	_	01	DSP clock division factor 16				
0		0	OFF, normal mode	10	Not allowed	 0 to 7/(2Fs) by 1/(2Fs) steps 	Fs/4	Refer to Section 5.6	
0		0	_	11	Not allowed				
1		1		00	DSP clock division factor 8				
1	_	1	1	01	DSP clock division factor 16	0 to 7/(2Fs) by		Not recommende	
1	_	1	ON	10	Not allowed	1/(2Fs) steps	Fs/4	mode, not guaranteed	
1		1	-	11	Not allowed				
1	2:1	0		00	DSP clock division factor 4				
1	-	0	1	01	DSP clock division factor 8			Defende Orati	
1	-	0	OFF, normal mode	10	Not allowed	 0 to 7/(2Fs) by 1/(2Fs) steps 	Fs/2	Refer to Section 5.6	
1	1	0	-	11	Not allowed				

Table 5-5. OCDS, IUCM, MUX, PSS Combinations Summary

Note: Behaviour according to MUX, OCDS and PSS combination is independent of output mode (MODE).

5.9 Synchronization functions for multi-DAC operation

In order to synchronize the timings, a SYNC operation can be generated.

After the application of the SYNC signal the DSP clock from the DAC will stop for a period and after a constant and known time the DSP clock will start up again.

There are two SYNC functions integrated in this DAC:

- a power up reset, which is triggered by the power supplies if the dedicated power up sequence is applied Vccd => Vcca3 => Vcca5;
- External SYNC pulse applied on (SYNC, SYNCN).

The external SYNC is LVDS compatible (same buffer as for the digital input data). It is active high.

Depending on the settings for OCDS, PSS and also the MUX ratio the width of the SYNC pulse must be greater than a certain number of external clock pulses. It is also necessary that the sync pulse be synchronized with the system clock and is an integer number of clock pulses. See application note (ref 1087) for further details.

Figure 5-16. Reset Timing Diagram (4:1 MUX)

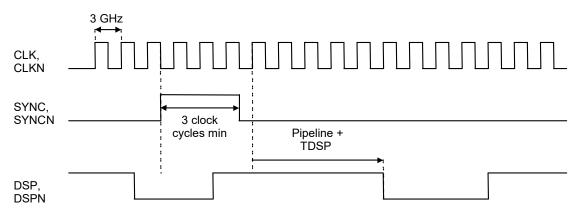
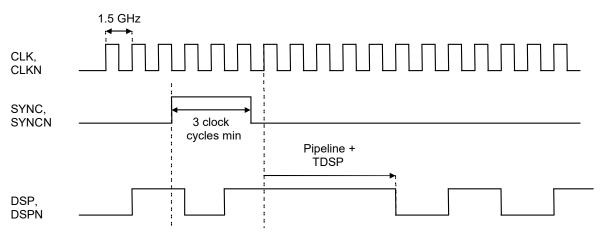


Figure 5-17. Reset Timing Diagram (2:1 MUX)



Important note:

For EV12DS130A:

- See erratasheet (ref 1125) for SYNC condition of use.
- SYNC, SYNCN pins have to be driven.

For EV12DS130B:

- SYNC, SYNCN pins can be left floating if unused.
- No specific timing constraints (other than T1 and T2) are required.

5.10 Gain Adjust GA Function

This function allows to adjust the internal gain of the DAC to cancel the initial gain deviation.

The gain of the DAC can be adjusted by $\pm 11\%$ by tuning the voltage applied on GA by varying GA potential from 0 to V_{CCA3}.

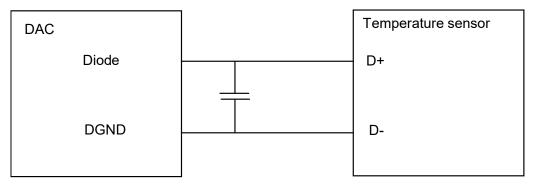
GA max is given for GA = 0 and GA min for GA = V_{CCA3}

5.11 Diode Function

A diode is available to monitor the die junction temperature of the DAC.

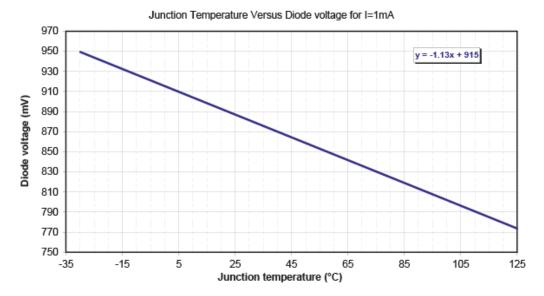
For the measurement of die junction temperature, you may use a temperature sensor.

Figure 5-18. Temperature DIODE Implementation



In characterization measurement a current of 1 mA is applied on the DIODE pin. The voltage across the DIODE pin and the DGND pin gives the junction temperature using the intrinsic diode characteristics below Figure 5-19.

Figure 5-19. Diode Characteristics for Die Junction Monitoring



6. PIN DESCRIPTION

Figure 6-1. Pinout View (Top View)

	1	2	3	4	5	6	7	8	9	10	11	12	13	14	15	16	_
A		VCCD	B 4	B5	B8	(B10)	B 9	(B11)	(C11)	C9	(C10)	C8	C5	C4	VCCD	DGND	A
В		VCCD	(B4N)	B5N	B8N	B10N	B9N	B11N	C11N	C9N	C10N	C8N	C5N	C4N	VCCD		В
С	B3	(B3N)	VCCD		(B7N)	B7	B 6	B6N	C6N	(C6)	(C7)	C7N		VCCD	C3N)	(C3)	С
D	B2	B2N		VCCD	VCCD							VCCD	VCCD		C2N	C2	D
Е	(B1)	B1N	B 0				VCCD	VCCD	VCCD	VCCD				(C0)	(C1N)	(C1)	Е
F	(A10)	(A10N)	BON		VCCD			VCCD	VCCD			VCCD		CON		D10	F
G	(A11)	(A11N)	(A9N)		VCCD	VCCD		AGND			VCCD	VCCD		D9N	(D11N)	(D11)	G
Н	(A8)	A8N	(A9)			VCCD	AGND	AGND	AGND	AGND	VCCD			D 9			Н
J	(A6)	A6N	A1N			(VCCA3	AGND	AGND	AGND	AGND	(VCCA3			D1N		 	J
K	(A3)	A3N	(A1)	VCCA3	VCCA3	VCCA3	AGND	AGND	AGND	AGND	VCCA3	(VCCA3	VCCA3		D3N	D 3	К
L	A7	(A7N)	(A2)				VCCAS	(VCCA5	VCCA5	VCCAS				 D2			L
М	(A5)	(A5N)	(A2N)				AGND	(VCCA5	AGND	VCCAS	NC of DGND	IUCM		(D2N)	D5N		М
Ν	A0	AON	DSPN	HTVF		STVF	AGND	VCCA5	AGND	VCCA5							N
Ρ	(A4)	(A4N)	DSP	GA		AGND	AGND	AGND	AGND	AGND	AGND				(D4N)	D4	Ρ
R					SYNC		AGND	AGND	AGND	AGND			(PSS1)	(PSS2)			R
т					SYNC	CLK	AGND	AGND	OUT	OUTN	AGND	MODE	PSSO	MUX		DGND	т
	1	2	3	4	5	6	7	8	9	10	11	12	13	14	15	16	I

Table 6-1. Pinout Table

Signal Name	Pin number	Description	Direction	Equivalent simplified schematics		
Power supplies						
V _{CCA5}	L7, L8, L9, L10, M8, M10, N8, N10	5.0V analog power supplies Referenced to AGND				

Signal Name	Pin number	Description	Direction	Equivalent simplified schematics
V _{CCA3}	J6, J11, K4, K5, K6, K11, K12, K13	3.3V analog power supply Referenced to AGND	NA	
V _{CCD}	A2, A15, B2, B15, C3, C14, D4, D5, D12, D13, E7, E8, E9, E10, F5, F8, F9, F12, G5, G6, G11, G12, H6, H11	3.3V digital power supply Referenced to DGND	NA	
AGND	G7, G8, G9, G10, H7, H8, H9, H10, J7, J8, J9, J10, K7, K8, K9, K10, M7, M9, N7, N9, P6, P7, P8, P9, P10, P11, R7, R8, R9, R10, R11, T7, T8, T11	Analog Ground	NA	
DGND	A16, B1, B16, C4, C13, D3, D6, D7, D8, D9, D10, D11, D14, E4, E5, E6, E11, E12, E13, F4, F6, F7, F10, F11, F13, G4, G13, H4, H5, H12, H13, J4, J5, J12, J13, L4, L5, L6, L11, L12, L13, M4, M5, M13, N5, N11, N12, N13, P5, P12, P13, R1, R2, R3, R15, R16, T1, T2, T3, T15, T16	Digital Ground	NA	
Clock Signals	, , , , .	1	1	
CLK, CLKN	T6, R6	Sampling clock signal input (In-phase and inverted phase)	1	CLKN 50Ω 2.5 V 50Ω 3.75 pF AGND

Signal Name	Pin number	Description	Direction	Equivalent simplified schematics
DSP, DSPN	P3, N3	Output clock (in-phase and inverted phase)	0	VCCD DSP, DSP, DSPN 145Ω DGND
Analog Output S	Signal			
OUT, OUTN	T9, T10	In phase and inverted phase analog output signal (differential termination required)	0	VCCA5 500 OUT OUT OUTN Current Switches and sources AGND
		In phase, inverted phase	1	F
A0, A0N A1, A1N A2, A2N A3, A3N A4, A4N A5, A5N A6, A6N A7, A7N A8, A8N A9, A9N A10, A10N A11, A11N	N1, N2 K3, J3 L3, M3 K1, K2 P1, P2 M1, M2 J1, J2 L1, L2 H1, H2 H3, G3 F1, F2 G1, G2	In-phase, inverted phase Digital input Port A Data A0, A0N is the LSB Data A11, A11N is the MSB	1	50Ω 50Ω 50Ω J J J J J J J GND J GND
B0, B0N B1, B1N B2, B2N B3, B3N B4, B4N B5, B5N B6, B6N B7, B7N B8, B8N B9, B9N B10, B10N B11, B11N	E3, F3 E1, E2 D1, D2 C1, C2 A3, B3 A4, B4 C7, C8 C6, C5 A5, B5 A7, B7 A6, B6 A8, B8	In-phase, inverted phase Digital input Port B Data B0, B0N is the LSB Data B11, B11N is the MSB	1	

Signal Name	Pin number	Description	Direction	Equivalent simplified schematics
C0, C0N C1, C1N C2, C2N C3, C3N C4, C4N C5, C5N C6, C6N C7, C7N C8, C8N C9, C9N C10, C10N C11, C11N	E14, F14 E16, E15 D16, D15 C16, C15 A14, B14 A13, B13 C10, C9 C11, C12 A12, B12 A10, B10 A11, B11 A9, B9	In-phase, inverted phase Digital input Port D Data D0, D0N is the LSB Data D11, D11N is the MSB	1	
D0, D0N D1, D1N D2, D2N D3, D3N D4, D4N D5, D5N D6, D6N D7, D7N D8, D8N D9, D9N D10, D10N D11, D11N	N16, N15 K14, J14 L14, M14 K16, K15 P16, P15 M16, M15 J16, J15 L16, L15 H16, H15 H14, G14 F16, F15 G16, G15	In-phase, inverted phase Digital input Port D Data D0, D0N is the LSB Data D11, D11N is the MSB	1	
IDC_P IDC_N	R4 T4	Input data check	I	
SYNC, SYNCN	T5 R5	In phase and Inverted phase reset signal	I	
Digital Input Sig	nals			
A0, A0N A1, A1N A2, A2N A3, A3N A4, A4N A5, A5N A6, A6N A7, A7N A8, A8N A9, A9N A10, A10N A11, A11N	N1, N2 K3, J3 L3, M3 K1, K2 P1, P2 M1, M2 J1, J2 L1, L2 H1, H2 H3, G3 F1, F2 G1, G2	In-phase, inverted phase Digital input Port A Data A0, A0N is the LSB Data A11, A11N is the MSB	1	50Ω
B0, B0N B1, B1N B2, B2N B3, B3N B4, B4N B5, B5N B6, B6N B7, B7N B8, B8N B9, B9N B10, B10N B11, B11N	E3, F3 E1, E2 D1, D2 C1, C2 A3, B3 A4, B4 C7, C8 C6, C5 A5, B5 A7, B7 A6, B6 A8, B8	In-phase, inverted phase Digital input Port B Data B0, B0N is the LSB Data B11, B11N is the MSB	1	
C0, C0N C1, C1N C2, C2N	E14, F14 E16, E15 D16, D15	In-phase, inverted phase Digital input Port D	1	

Signal Name	Pin number	Description	Direction	Equivalent simplified schematics
C3, C3N C4, C4N C5, C5N C6, C6N C7, C7N C8, C8N C9, C9N C10, C10N C11, C11N	C16, C15 A14, B14 A13, B13 C10, C9 C11, C12 A12, B12 A10, B10 A11, B11 A9, B9	Data D0, D0N is the LSB Data D11, D11N is the MSB		
D0, D0N D1, D1N D2, D2N D3, D3N D4, D4N D5, D5N D6, D6N D7, D7N D8, D8N D9, D9N D10, D10N D11, D11N	N16, N15 K14, J14 L14, M14 K16, K15 P16, P15 M16, M15 J16, J15 L16, L15 H16, H15 H14, G14 F16, F15 G16, G15	In-phase, inverted phase Digital input Port D Data D0, D0N is the LSB Data D11, D11N is the MSB	1	
IDC_P IDC_N	R4 T4	Input data check	1	
SYNC, SYNCN	T5 R5	In phase and Inverted phase reset signal	1	
Control Signals	6			
HTVF	N4	Hold time violation flag	0	
STVF	N6	Setup time violation flag	0	20Ω HTVF or STVF
PSS0 PSS1 PSS2	T13 R13 R14	Phase Shift Select (PSS2 is the MSB)	1	VССР
MODE0 MODE1	T12 R12	DAC Mode selection bits: - RTZ - NRZ - Narrow RTZ - RF	1	13 kΩ 20 kΩ
OCDS0 OCDS1	N14 P14	Output Clock Division Select = these bits allow to select the clock division factor applied on the DSP, DSPN signal.	1	Input 200Ω 33 kΩ
MUX	T14	MUX selection	1	DGND

Signal Name	Pin number	Description	Direction	Equivalent simplified schematics
IUCM	M12	Input underclocking mode enable	I	
GA	P4	Gain adjust		GA 1 kΩ 300Ω 2.5 kΩ 26.6 pF 2.5 kΩ 4 pF
Diode	M6	Diode for die junction temperature monitoring function	1	SUB DGND_DIODE
NC	M11	Reserved pin, NC, can be connected to DGND		

7. CHARACTERIZATION RESULTS

Unless otherwise specified results are given at room temperature (Tj ~ 60° C), nominal power supply, in 4:1 MUX mode, gain at nominal setting.

7.1 Static Performances

7.1.1 DC Gain Characterization



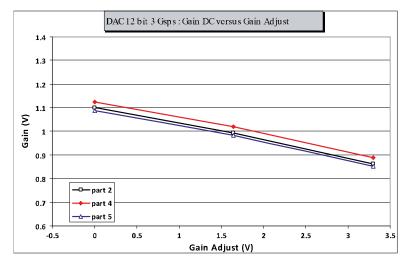
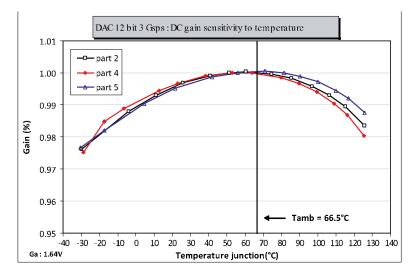
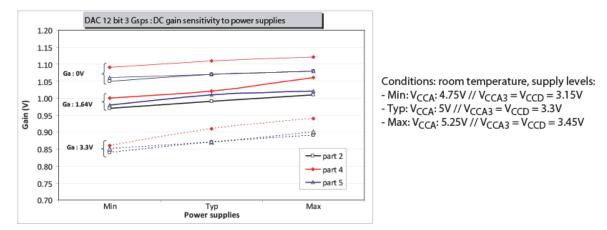


Figure 7-2. DAC DC Gain Drift from Unity Gain vs Temperature (Measured in NRZ Mode)

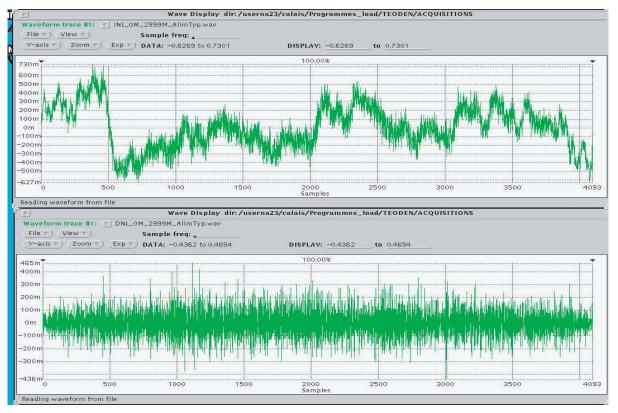






7.1.2 Static Linearity





INL reflects a true 12 bit DAC.

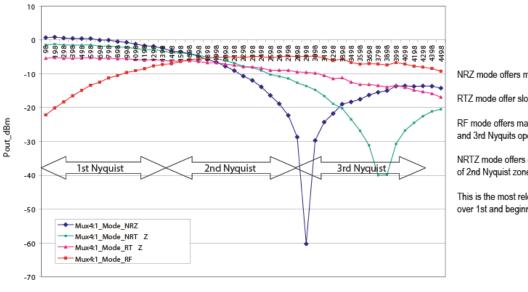
Low DNL values reflect a strictly monotonous 12 bit DAC.

7.2 AC Performances

7.2.1 Available Output Power vs Fout.

The following plots summarize characterization results, for a Fout sweep from 98 MHz to 4498 MHz (step 100 MHz).

Figure 7-5. Available Pout vs Fout from 98 MHz to 4498 MHz in the 4 Output Modes at 3 Gsps



NRZ mode offers max power for 1st Nyquist operation.

RTZ mode offer slow roll off for 2nd Nyquist operation.

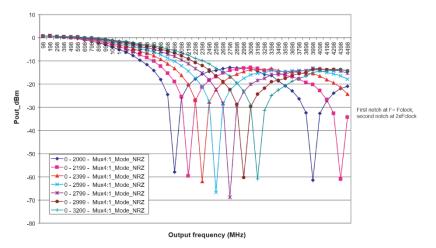
RF mode offers maximum power over 2nd and 3rd Nyquits operation.

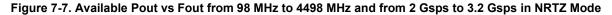
NRTZ mode offers optimum power over full 1st and first half of 2nd Nyquist zones.

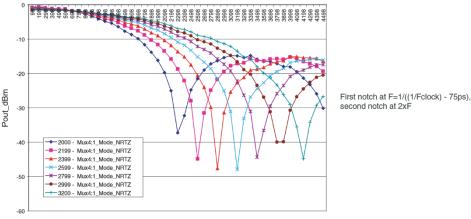
This is the most relevant in term of performance for operation over 1st and beginning of 2nd Nyquist zone.

Output frequency (MHz)

Figure 7-6. Available Pout vs Fout from 98 MHz to 4498 MHz and from 2 Gsps to 3.2 Gsps in NRZ Mode

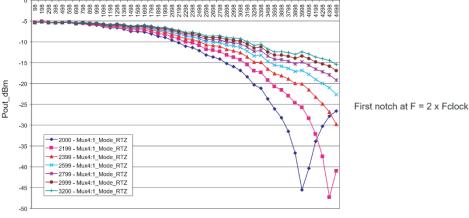






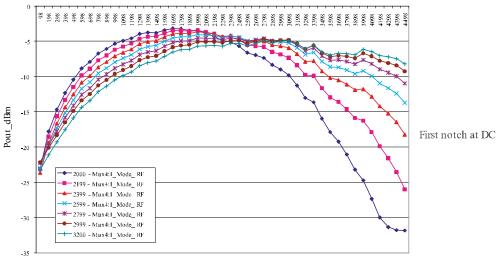
Output frequency (MHz)





Output frequency (MHz)





Output frequency (MHz)

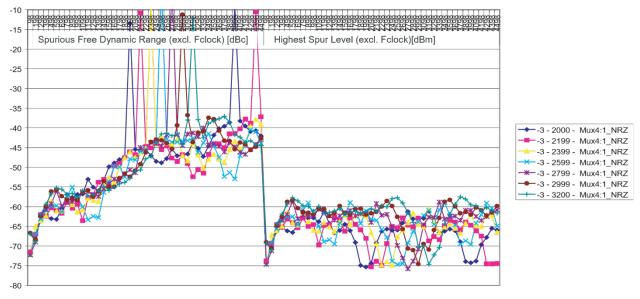
EV12DS130AG/EV12DS130BG

7.2.2 Single Tone Measurements

The following plots summarize characterization results in MUX4:1 mode, for an Fout sweep from 98 MHz to 4498 MHz (step 100 MHz).

The left side of the plot gives SFDR expressed in dBc and the right side gives HSL (Highest Spur Level excluding Fclock spur) expressed in dBm.



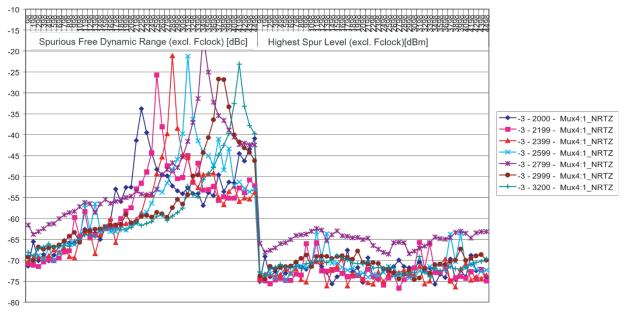


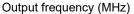
Output frequency (MHz)

NRZ mode is only relevant for Fout below 400 MHz.

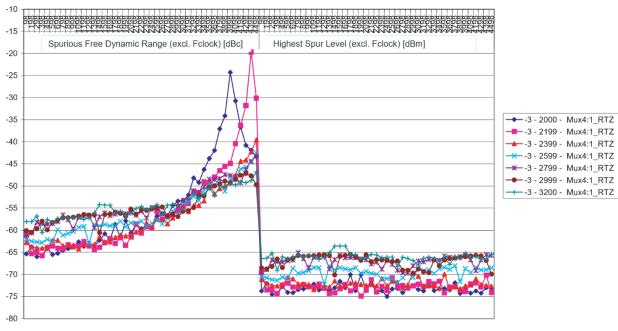
The spikes in the SFDR are caused by normalization artefacts due to the Sinc(x) null.







NRTZ mode brings significant improvement regarding NRZ mode. This mode concentrates the benefits of both NRZ mode (high power available) and RTZ mode (extended available dynamic range). The spikes in the SFDR are caused by normalization artefacts due to the Sinc(x) null.

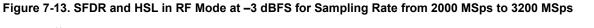


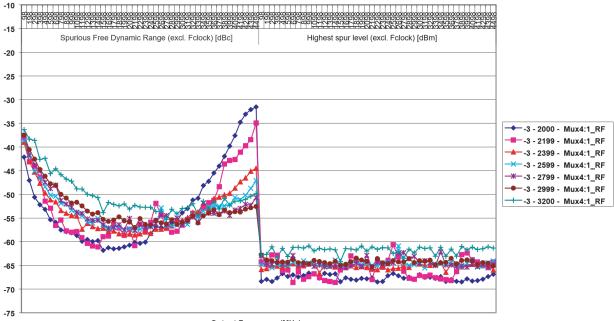


Output frequency (MHz)

RTZ mode allows for operation over the 3 first Nyquist zones.

In first and beginning of second Nyquist zone NRTZ mode is mode relevant. The spikes in the SFDR are caused by normalization artefacts due to the Sinc(x) null.

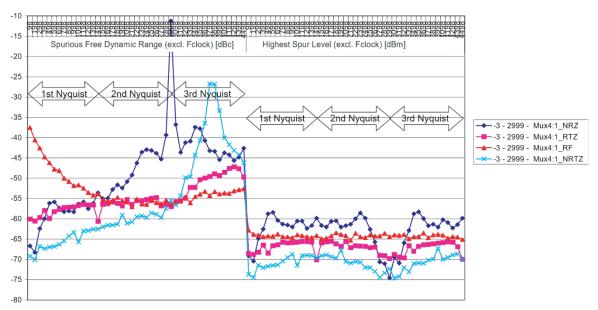




Output Frequency (MHz)

RF mode allows for operation over 3rd Nyquist zones. Performances are not sensitive to output level. Performance roll off occurs beyond 3000 MSps.

Figure 7-14. Comparison of the 4 Output Modes at 2999 MSps and at -3 dBFS: SFDR and HSL



Output frequency (MHz)

NRZ is interesting only at the very beginning of the first Nyquist zone.

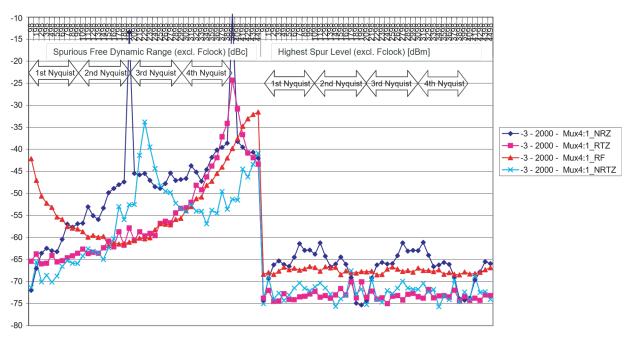
NRTZ is relevant over 1st 2nd and 4th Nyquist zones.

RTZ is relevant over 2nd and 3rd Nyquist zones.

RF mode displays a good behavior over 2nd and 3rd Nyquist Zones.

The spikes in the SFDR are caused by normalization artefacts due to the Sinc(x) null

Figure 7-15. Comparison of the 4 Output Modes at 2000 MSps and -3 dBFS: SFDR and HSL



Output frequency (MHz)

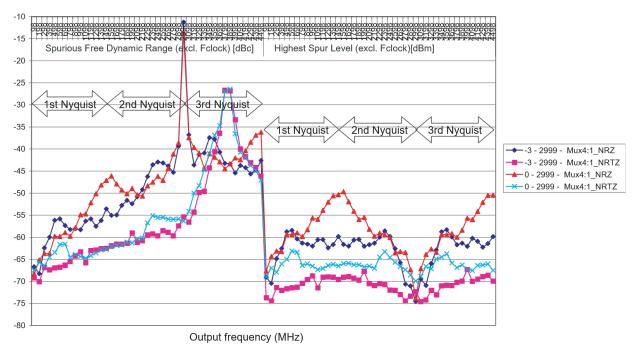
NRTZ is the most relevant over 1st Nyquist zone, 1st half of 2nd Nyquits zone and 4th Nyquist zone.

RF mode is the best choice for 2nd half of 2nd Nyquist Zone and 3rd Nyquist zone.

RTZ gives relevant performances over the three first Nyquist zones.

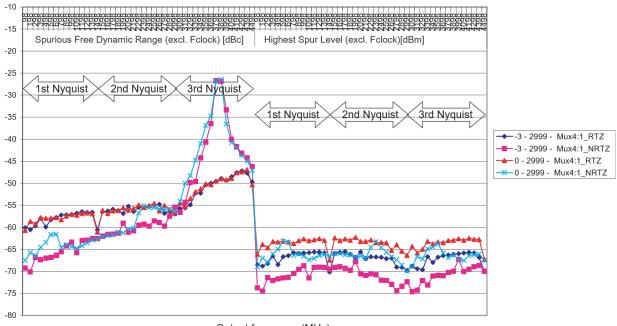
The spikes in the SFDR are caused by normalization artefacts due to the Sinc(x) null

Figure 7-16. Comparison of NRZ and NRTZ Modes at Full Scale and –3 dBFS at 2999 MSps: SFDR and HSL (Excluding Fclock)



NRTZ gives better performances over 1st and 2nd Nyquist zone, and is much less sensitive to output level.

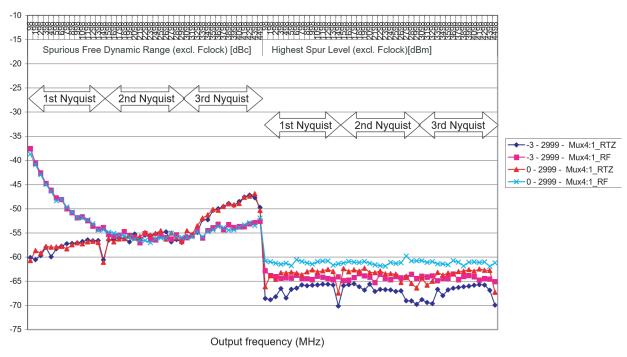
Figure 7-17. Comparison of NRTZ and RTZ Modes at Full Scale and –3 dBFS at 2999 MSps: SFDR and HSL



Output frequency (MHz)

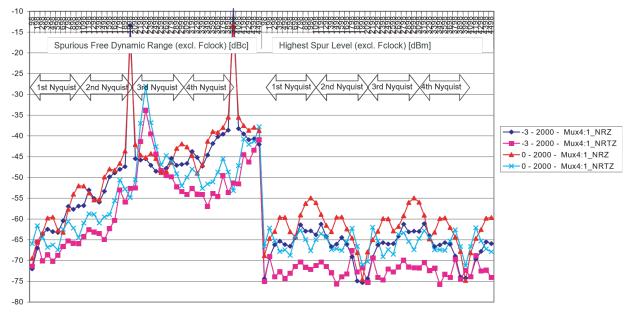
NRTZ is more relevant for 1st Nyquist zone and 1st half of 2nd Nyquist zone. Beyond middle of second Nyquist zone RTZ mode is more relevant.





RF mode gives better performance over 3rd Nyquist zone.

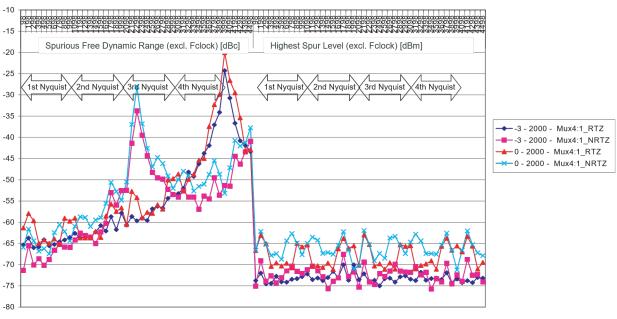
Figure 7-19. Comparison of NRZ and NRTZ Modes at Full Scale and –3 dBFS at 2000 MSps: SFDR and HSL (Excluding Fclock)



Output frequency (MHz)

NRTZ linearity is slightly improved reducing the sampling rate to 2000 MSps, possibility of operation over the 4th Nyquist zone is demonstrated.

Figure 7-20. Comparison of NTRZ and RTZ Modes at Full Scale and –3 dBFS at 2000 MSps: SFDR and HSL (Excluding Fclock)



Output frequency (MHz)

NRTZ mode is relevant in 1st, 2nd Nyquist zones and is still usable over 4th Nyquist zone with SFDR in excess of 50 dBc.

7.2.3 Single tone measurements: typical spectra at 3Gsps

The following figures show typical SFDR spectra obtained for the four DAC modes on an EV12DS130A/B device.

Conditions: typical power supplies, ambient temperature, MUX4:1, Fs = 3 Gsps.

Figure 7-21. Typical SFDR spectrum in NRZ mode. Fout = 100MHz (1st Nyquist), MUX4:1, Fs = 3Gsps. SFDR = 67dBc

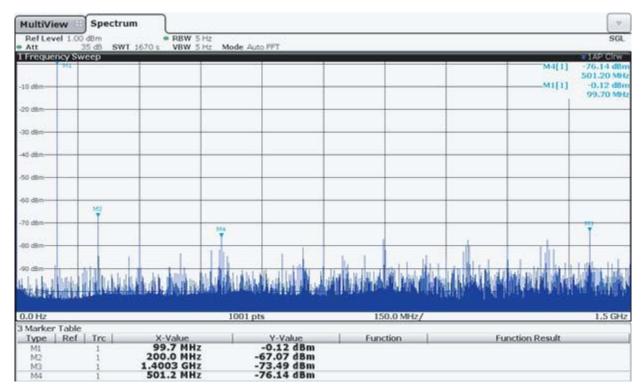


Figure 7-22. Typical SFDR spectrum in NRTZ mode. Fout = 1800MHz (2nd Nyquist), MUX4:1, Fs = 3Gsps. SFDR = 61dBc

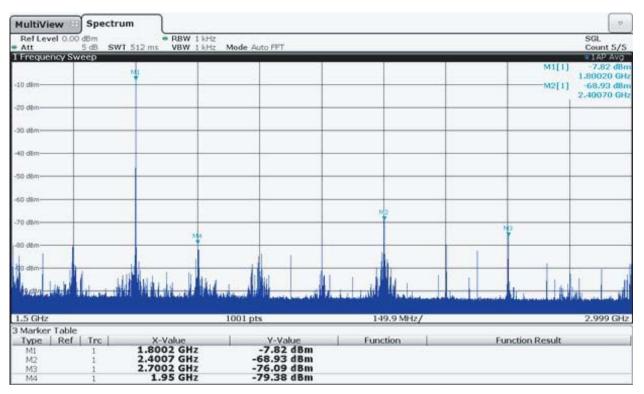


Figure 7-23. Typical SFDR spectrum in RTZ mode. Fout = 2900MHz (2nd Nyquist), MUX4:1, Fs = 3Gsps. SFDR = 59dBc.

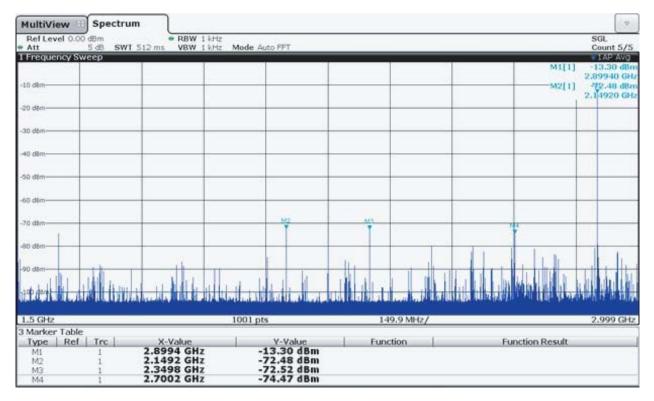
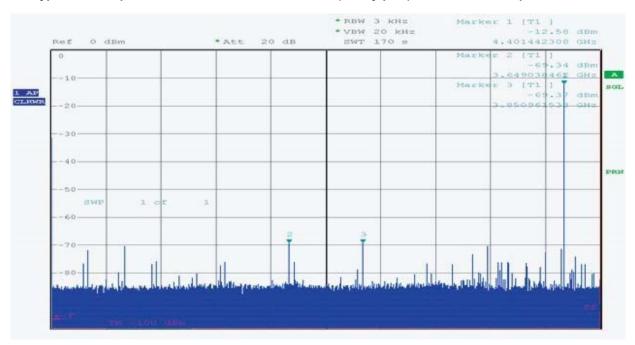


Figure 7-24. Typical SFDR spectrum in RF mode. Fout = 4400MHz (3rd Nyquist), MUX4:1, Fs = 3Gsps. SFDR = 56 dBc

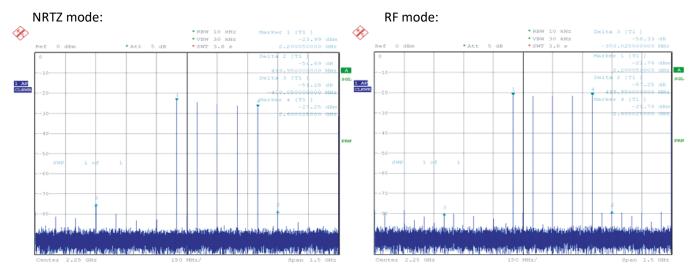


7.2.4 Multi Tone Measurements

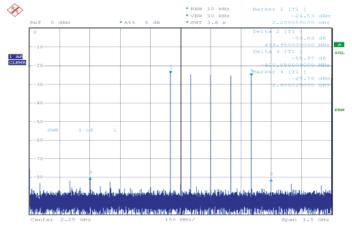
A five tones pattern (400 MHz, 500 MHz, 600 MHz, 700 MHz and 800 MHz) is applied to the DAC operating at 3 Gsps and results are observed in the 2nd, 3rd, 4th and 5th Nyquist zones.

Results are given in the most relevant mode considering the Nyquist zone observed.

Figure 7-25. Observation of the 2nd Nyquist Zone (Tones are pushed from 2.2 GHz to 2.6 GHz): NRTZ, RF and RTZ Modes



RTZ mode:



	Fout (MHz)	Pout (dBm)	SFDR (freq)	SFDR(dBc)
NRTZ	2200	-23,99	1800	-51,28
RTZ	2200	-24,53	1800	-55,97
RF	2200	-21,76	2700	-57,25

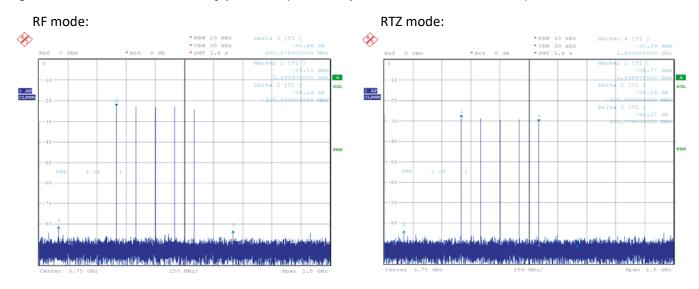
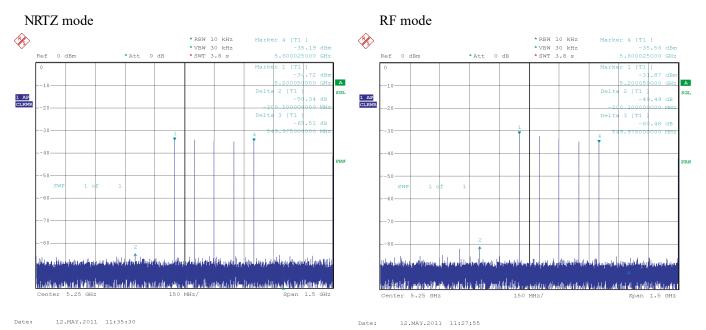


Figure 7-26. Observation of the 3rd Nyquist Zone (Tones are pushed from 3.4GHz to 3.8GHz): RF and RTZ Modes

	Fout (MHz)	Pout (dBm)	SFDR (freq)	SFDR (dBc)
NRTZ	3400	-39.43	4000	-44.48
RTZ	3400	-28.77	3100	-55.14
RF	3400	-23.03	3100	-58.33

NRTZ performances are degraded because of the sinc attenuation (first notch in the first half of the 3rd Nyquist zone).

Figure 7-27. Observation of the 4th Nyquist Zone (Tones are pushed from 5.2 GHz to 5.6 GHz): NRTZ and RF Modes



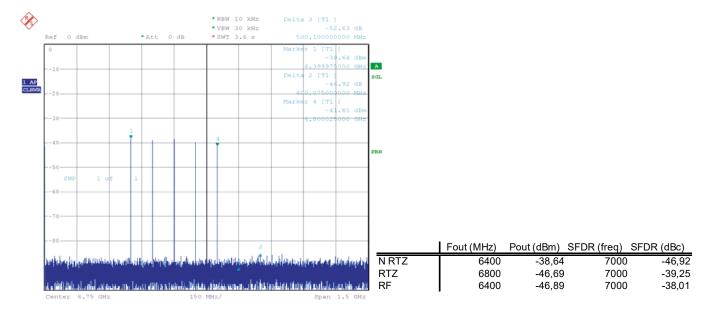
EV12DS130AG/EV12DS130BG

	Fout (MHz)	Pout (dBm)	SFDR (freq)	SFDR (dBc)
NRTZ	5200	-34.72	5000	-50.34
RTZ	5200	-40.37	4700	-45
RF	5200	-31.87	4700	-49.49

RTZ mode is degraded because of the sinc attenuation (first notch at the end of the 4th Nyquist zone). RF mode offers significantly more power than RTZ mode, this is why we still have acceptable performances.

NRTZ operation is possible because the 4th Nyquist zone is fully included in the secondary spectral lobe.

Figure 7-28. Observation of the 5th Nyquist Zone (Tones are pushed from 6.4 GHz to 6.8 GHz): NRTZ Mode

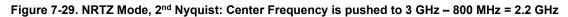


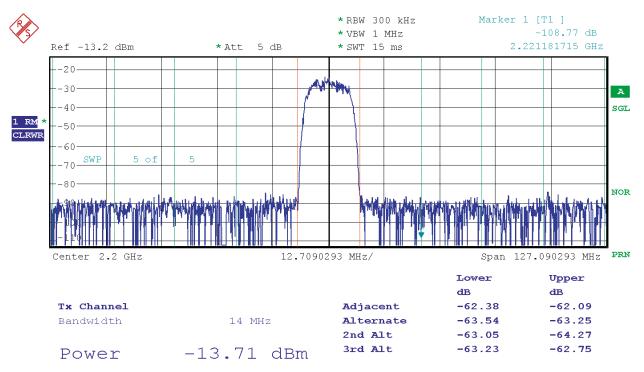
NRTZ mode is still usable in the 5th Nyquist zone (SFDR in excess of 46 dB).

7.2.5 Direct Microwave Synthesis Capability Measurements: ACPR

Measurements given hereafter are performed on the DAC at 3 Gsps with a 10 MHz wide QPSK pattern centered on 800 MHz.

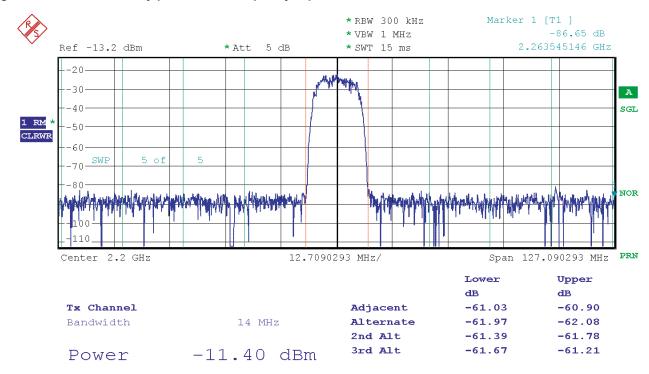
Results are observed in 2nd, 3rd, 4th and 5th Nyquist zones and are given only for the most relevant modes (that is RF and/or NRTZ modes).





ACPR is in excess of 62 dB. DMWS capability is proven for second Nyquist in NRTZ mode.

Figure 7-30. RF Mode, 2nd Nyquist: Center Frequency is pushed to 3 GHz – 800 MHz = 2.2 GHz



EV12DS130AG/EV12DS130BG

ACPR is in excess of 60 dB. DMWS capability is proven for the second Nyquist zone in RF mode with slightly reduced dynamic range regarding NRTZ mode but with increased output power.

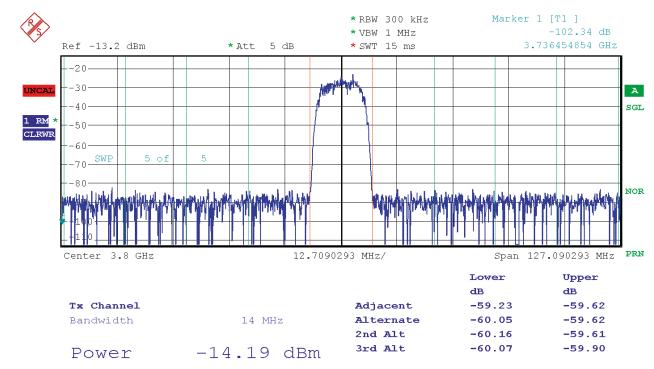
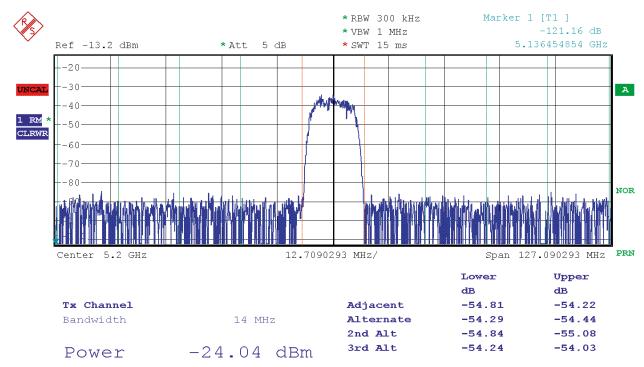


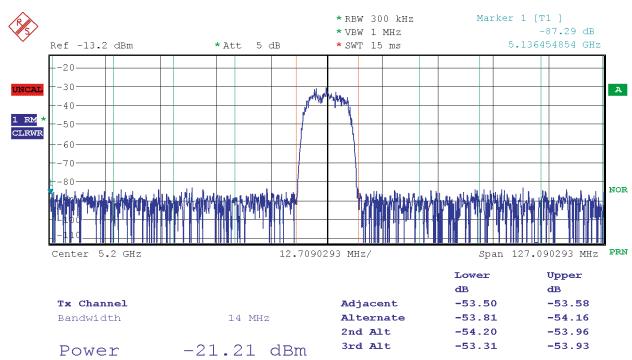
Figure 7-31. RF Mode, 3rd Nyquist Zone: Center Frequency is pushed to 3 GHz+ 800 MHz = 3.8 GHz

ACPR is in excess of 59 dB. DMWS capability is proven for the third Nyquist zone in RF mode.

Note: due to the notch of available Pout near the middle of the third Nyquist zone, the NRTZ mode is not relevant for DMWS in the third Nyquist zone.







ACPR is in excess of 54 dB. DMWS capability is proven for the fourth Nyquist zone in NRTZ mode.



ACPR is in excess of 53 dB. DMWS capability is proven for the fourth Nyquist zone in RF mode.

Note due to a notch of available Pout near the end of the 4th Nyquist zone in RF output mode, for DMWS beyond middle of 4th Nyquist zone it is recommended to use the NRTZ output mode instead of the RF output mode.

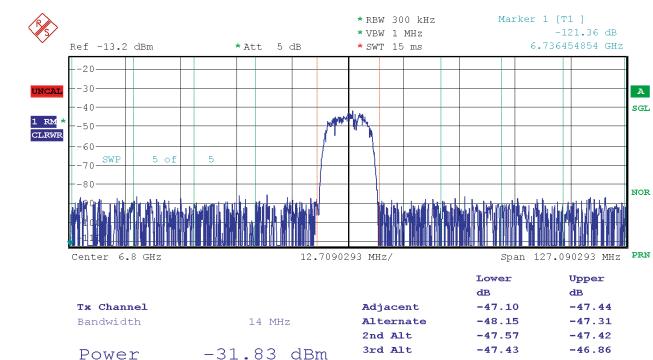


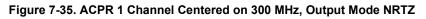
Figure 7-34. NRTZ Mode, 5th Nyquist Zone: Center Frequency is pushed to 6 GHz + 800 MHz = 6.8 GHz

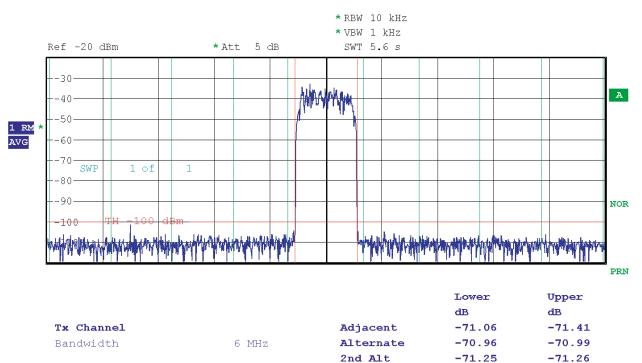
ACPR is still in excess of 47 dB. DMWS capability if proven for the fifth Nyquist zone in NRTZ mode with reduced available dynamic range.

7.2.6 DOCSIS v3.0 Capability Measurements

Measurements hereafter have been carried out on a soldered device EV12DS130A/B, in NRTZ mode at 3 GSps.

Note: Results illustrated hereafter (spectrum and zoom on notch) come from measurement on a EV12DS130A/B device (CI-CGA255 package). Measurements have been carried out using the ACP treatment of the spectrum analyzer Rhode & Schwarz FSU8, in RMS detection mode.





3rd Alt

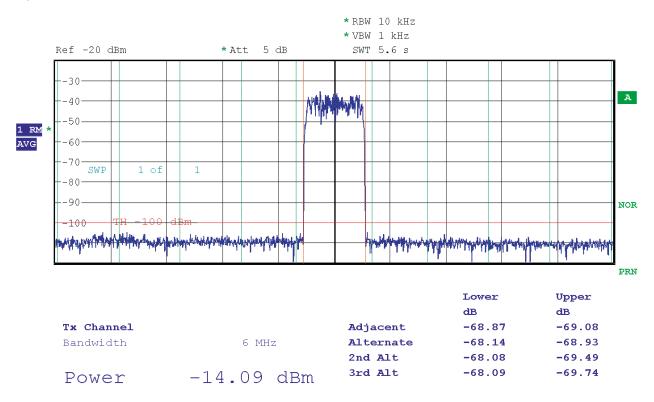
-71.72

-71.52



Power

-12.72 dBm



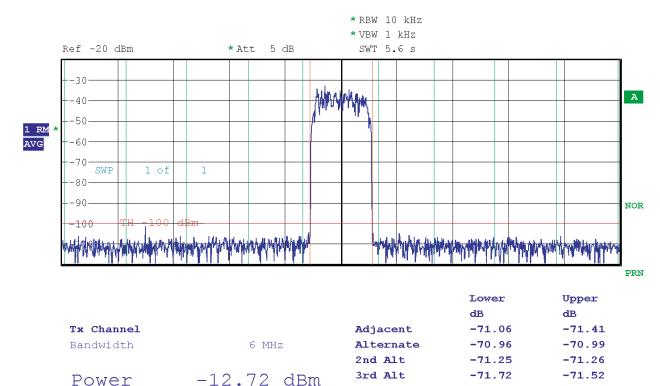
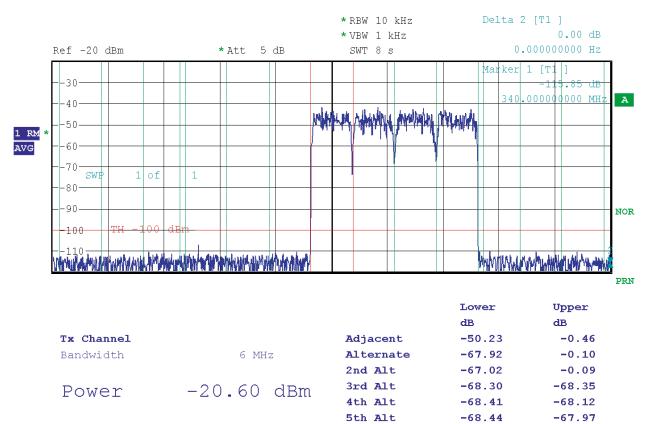


Figure 7-37. ACPR 1 channel centered on 300 MHz, Output Mode NRTZ

Figure 7-38. ACPR 4 Channels Centered on 300 MHz, Output Mode NRTZ



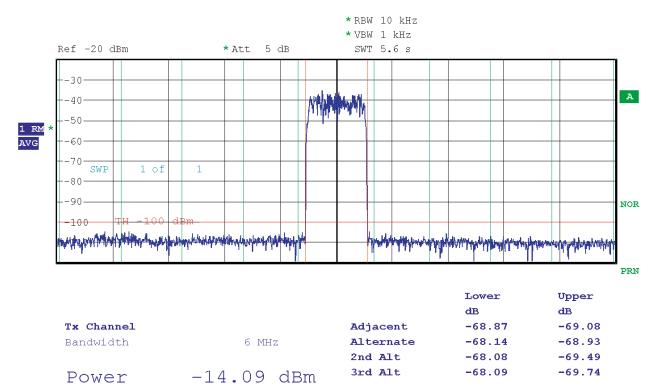
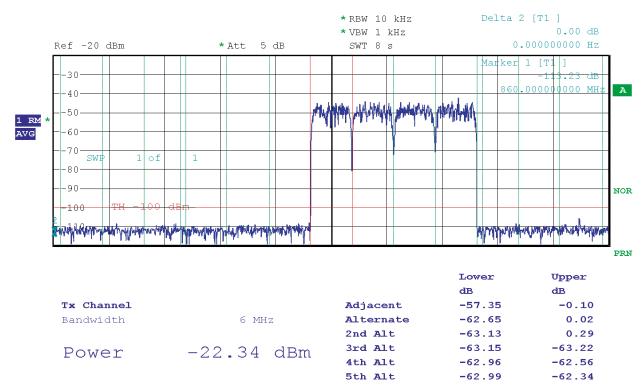


Figure 7-39. ACPR 1 Channel Centered on 900 MHz, Output Mode NRTZ





7.2.7 NPR Performance

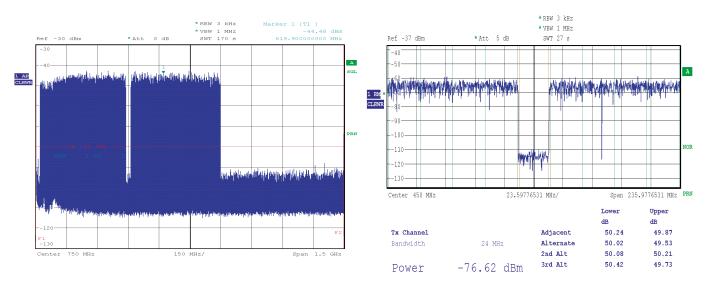
NPR measurements have been carried out at optimum loading factor (LF) for a 12 bit DAC, that is – 14 dBFS, with the DAC operating at 3 Gsps.

SNR can be computed from SNR measurement with the formula: $SNR_{[dB]} = NPR_{[dB]} + ILF_{[dB]}I - 3$.

ENOB can be computed with the formula: ENOB = $(SNR_{[dB]} - 1.76) / 6.02$.

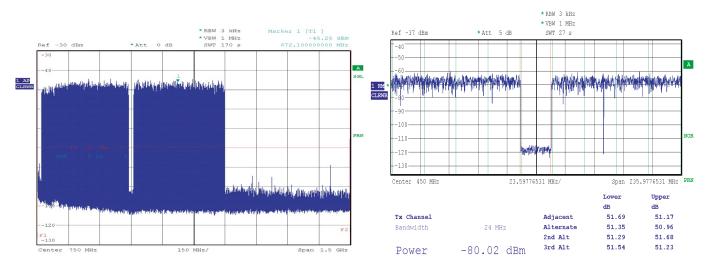
Note: Results illustrated hereafter (spectrum and zoom on notch) come from measurement on a EV12DS130A/B device (CI-CGA255 package). Measurements have been carried out using the ACP treatment of the spectrum analyzer Rhode & Schwarz FSU8, in RMS detection mode.

Figure 7-41. NPR in First Nyquist Zone, 20 MHz to 900 MHz Noise Pattern with a 25 MHz Notch Centered on 450 MHz, NRZ mode



Measured average NPR: 50.02 dB, therefore SNR = 61.02 dB and ENOB = 9.84 bit Effects at low frequency are due to balun and pattern.

Figure 7-42. NPR in First Nyquist Zone, 20 MHz to 900 MHz Noise Pattern with a 25 MHz Notch Centered on 450 MHz, NRTZ Mode

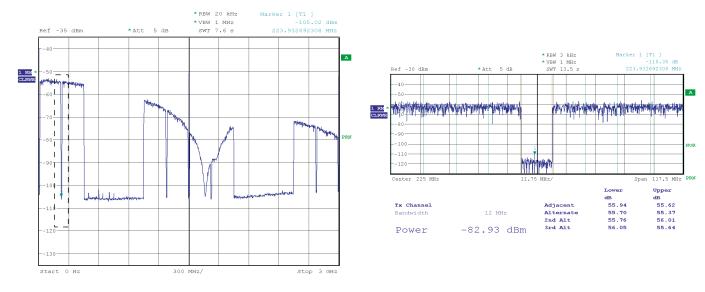


Measured average NPR: 51.36 dB, therefore SNR = 62.36 dB and ENOB = 10.07 bit.

Effects at low frequency are due to balun and pattern.

EV12DS130AG/EV12DS130BG

Figure 7-43. NPR in First Nyquist Zone, 10 MHz to 450 MHz Noise Pattern with a 12.5 MHz Notch centered on 225 MHz, NRTZ Mode at Fs = 1.5 Gsps

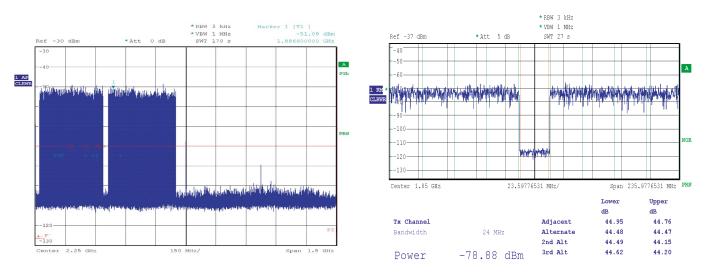


Date: 18.0CT.2011 15:50:38

Measured average NPR: 55.7 dB, therefore SNR = 66.7 dB and ENOB = 10.8 bit.

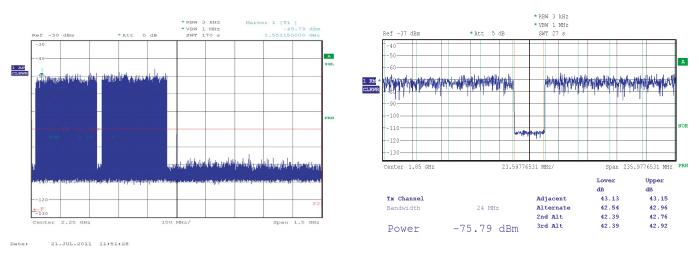
Effects at low frequency are due to balun and pattern.

Figure 7-44. NPR in second Nyquist Zone, 1520 MHz to 2200 MHz Noise Pattern with a 25 MHz Notch centered on 1850 MHz, RTZ mode

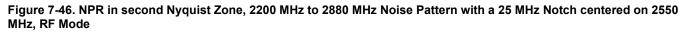


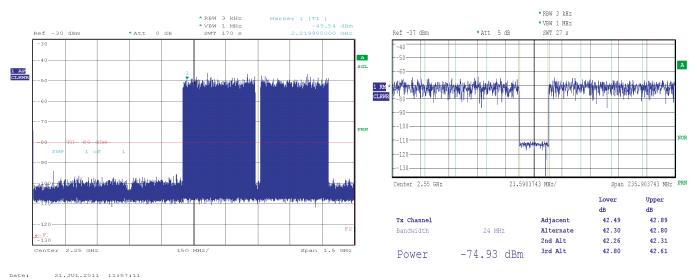
Measured average NPR: 44.6 dB, therefore SNR = 55.6 dB and ENOB = 8.94 bit

Figure 7-45. NPR in second Nyquist Zone, 1520 MHz to 2200 MHz noise pattern with a 25 MHz notch centered on 1850 MHz, RF Mode



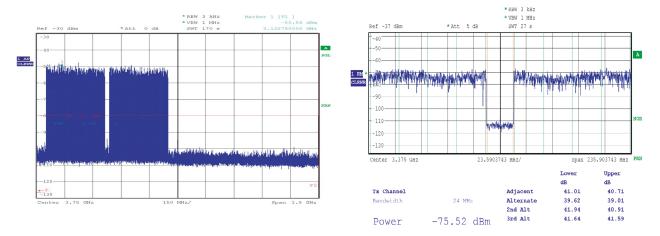
Measured average NPR: 42.78 dB, therefore SNR = 53.78 dB and ENOB = 8.64 bit





Measured average NPR: 42.56 dB, therefore SNR = 53.56 dB and ENOB = 8.6 bit.

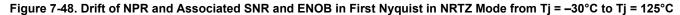


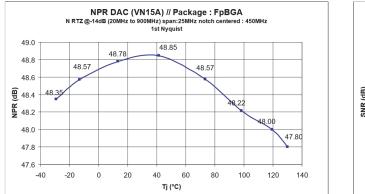


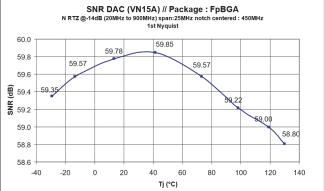
Measured average NPR: 40.08 dB, therefore SNR = 51.08 dB and ENOB = 8.19 bit

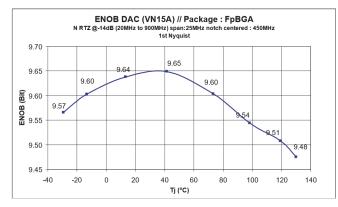
The following figures reflect the stability of NPR in first Nyquist in NRTZ mode (and therefore SNR and ENOB) versus temperature.

Measurements have been carried out at nominal power supply on an EV12DS130A/B, at 3 Gsps, with the FSU8 spectrum analyzer in RMS detection mode.





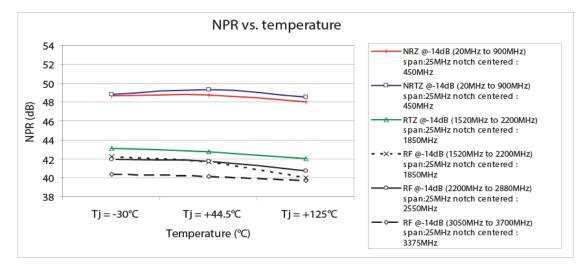




Optimum is at Tj = 40°C, degradation over temp is within 1 dB (or 0.15 effective bit).

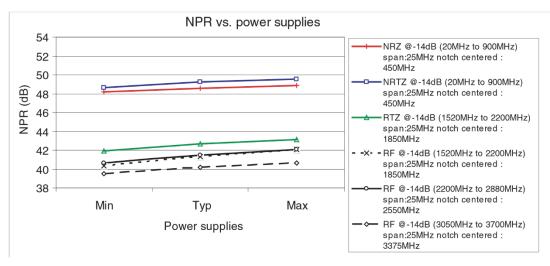
Measurements hereafter have been carried out on an EV12AS130AGS device at 3 Gsps, with the FSU8 spectrum analyzer in RMS detection mode.

Figure 7-49. Drift of NPR vs temperature in the 4 Output Modes at Nominal Supply



Conclusion: performances are stable in the four output modes against temperature.





Conditions: Typical, excepted: power supplies

Min: Vcca: 4.75V // Vcca3 = Vccd = 3.15V Typ: Vcca: 5.0V // Vcca3 = Vccd = 3.3V

Max: V_{CCA}: 5.25V // V_{CCA3} = V_{CCD} = 3.45V.

Conclusion: performances are fairly stable against power supply.

Note: NPR performance at lower clock frequencies is affected by power up sequence. See application note 1087 for further details.

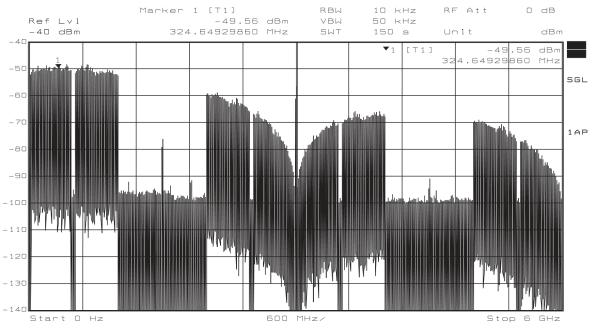
7.2.8 Spectrum over 4 Nyquist Zones in the Four Output Modes

Observation of a 1GHz broadband pattern with a 25 MHz notch centered on 500 MHz spectrum over 4 Nyquist zones at 3 Gsps (that is from DC to 6 GHz), measurements performed on an EV12DS130A/B device (CI-CGA 255 package, with an overall 6 GHz bandwidth limitation).

By periodisation of a sampled system each tone F_i of the pattern in the 1st Nyquist zone is duplicated as follows:

- 2nd Nyquist Zone: tone at Fclock Fi
- 3rd Nyquist Zone: tone at Fclock + Fi
- 4th Nyquist Zone: tone at 2*Fclock F_i

Figure 7-51. Spectrum over 4 Nyquist Zones at 3 Gsps in NRZ Output Mode



First Zero of the sinc() function is at Fclock.

EV12DS130AG/EV12DS130BG

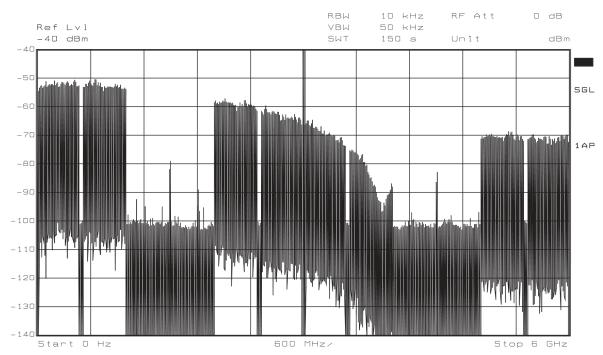
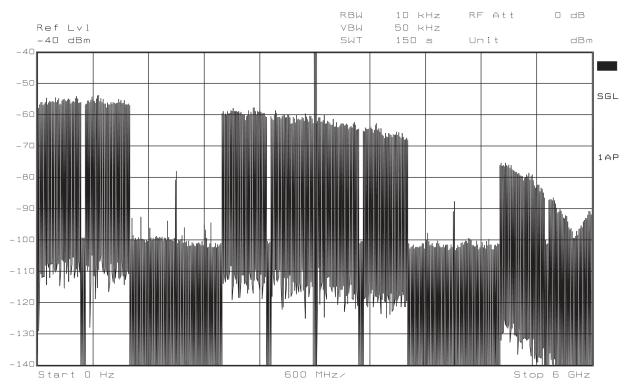


Figure 7-52. Spectrum over 4 Nyquist Zones at 3 Gsps in NRTZ Output Mode





First Zero of the sinc() function is slightly before 2*Fclock which indicates that the duty cycle of RTZ function is a little bit more than 50%, this is due to the balun which introduced some phase error beyond the 180 degrees between CLK and CLKN thus creating a duty cycle on the clock actually seen by the DAC.

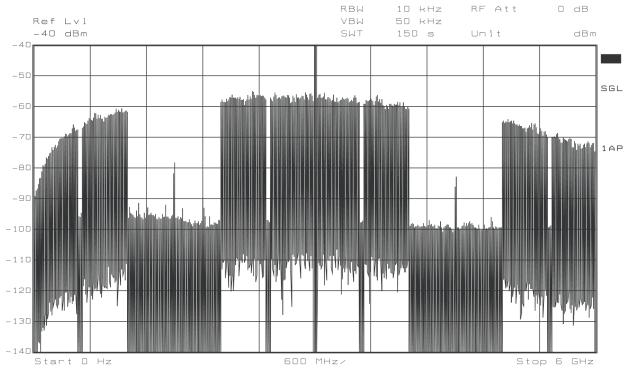


Figure 7-54. Spectrum over 4 Nyquist Zones at 3 Gsps in RF Output Mode

Measurements are showing a pretty good fit with theory, see Section 5.3 on page 16.

8. APPLICATION INFORMATION

For further details, please refer to application note 1087.

8.1 Analog Output (OUT/OUTN)

The analog output should be used in differential way as described in the figures below.

If the application requires a single-ended analog output, then a balun is necessary to generate a singleended signal from the differential output of the DAC.

Figure 8-1. Analog Output Differential Termination

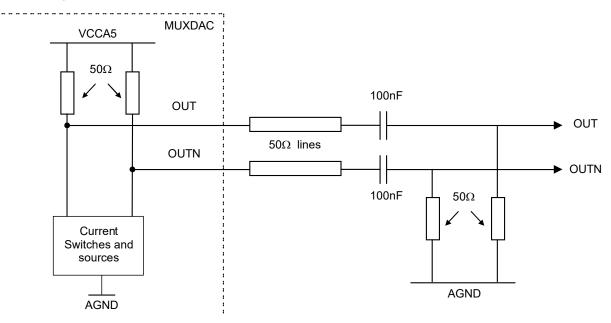
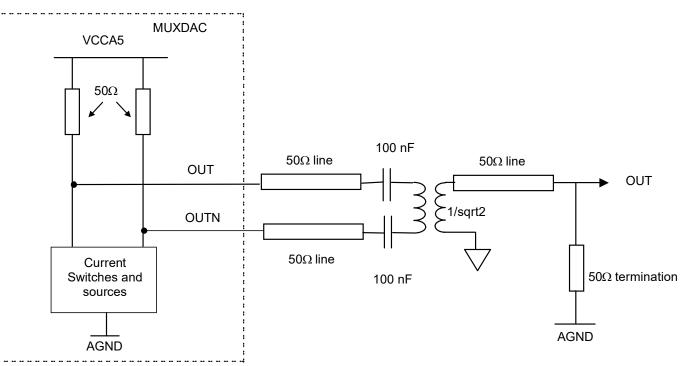


Figure 8-2. Analog Output Using a 1/ √2 Balun

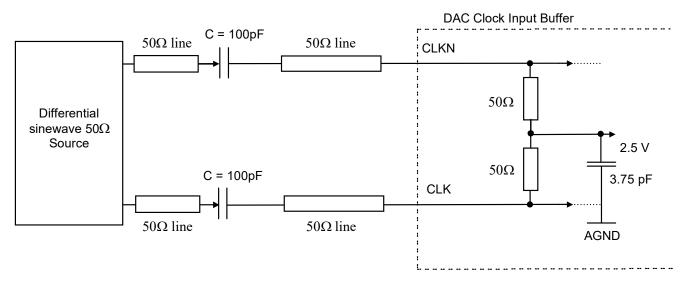


Note: The AC coupling capacitors should be chosen as broadband capacitors with a value depending on the application.

8.2 Clock Input (CLK/CLKN)

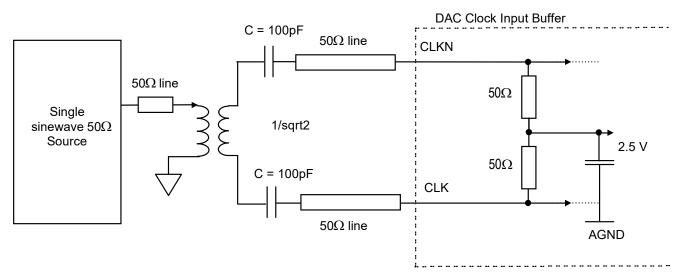
The DAC input clock (sampling clock) should be entered in differential mode as described in Figure 511.

Figure 8-3. Clock Input Differential Termination



Note: The buffer is internally pre-polarized to 2.5V (buffer between V_{CC5} and AGND).

Figure 8-4. Clock Input Differential with Balun



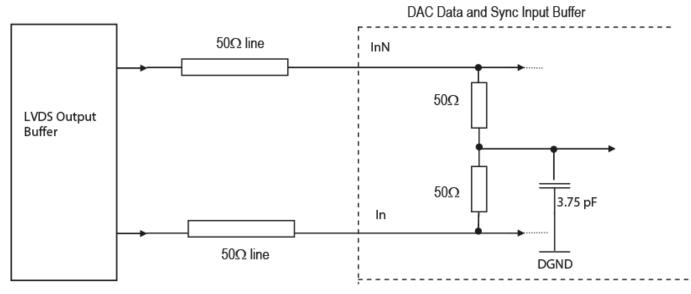
Note: The AC coupling capacitors should be chosen as broadband capacitors with a value depending on the application.

8.3 Digital Data, SYNC and IDC Inputs

LVDS buffers are used for the digital input data, the reset signal (active high) and IDC signal.

They are all internally terminated by $2 \times 50\Omega$ to ground via a 3.75 pF capacitor.

Figure 8-5. Digital Data, Reset and IDC Input Differential Termination



Notes:

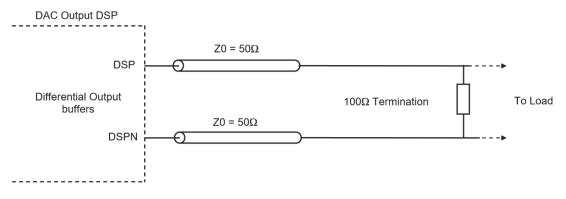
- 1. In the case when only two ports are used (2:1 MUX ratio), then the unused data should be left open (no connect).
- 2. Data and IDC signals should be routed on board with the same layout rules and the same length than the data.
- 3. In case SYNC is not used, it is necessary to bias the SYNC to 1.1V and SYNCN to 1.4V on EV12DS130A.

8.4 DSP Clock

The DSP, DSPN output clock signals are LVDS compatible.

They have to be terminated via a differential 100Ω termination as described in Figure 5-13.

Figure 8-6. DSP Output Differential Termination



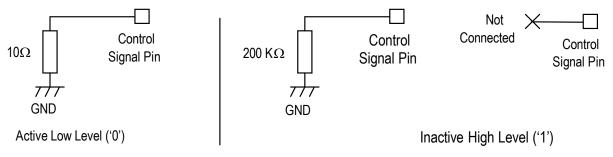
8.5 Control Signal Settings

The MUX, MODE, PSS and OCDS control signals use the same static input buffer.

Logic "1" = 200 K Ω to Ground, or tied to V_{CCD} = 3.3V or left open

Logic "0" = 10Ω to Ground or Grounded

Figure 8-7. Control Signal Settings



The control signal can be driven by FPGA.

Figure 8-8. Control Signal Settings with FPGA



Logic "1" > V_{IH} or V_{CCD} = 3.3V

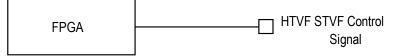
Logic "0" < VIL or 0V

8.6 HTVF and STVF Control Signal

The HTVF and STVF control signals is a 3.3V CMOS output buffer.

These signals could be acquired by FPGA.

Figure 8-9. Control Signal Settings with FPGA



In order to modify the VoL/VoH value, pull up and pull down resistances could be used, or a potential divider.

8.7 GA Function Signal

This function allows adjustment of the internal gain of the DAC.

The gain of the DAC can be tuned with applied analog voltage from 0 to VCCA3

This analog input signal could be generated by a DAC controlled by FPGA or microcontroller.

Figure 8-10. Control Signal Settings with GA



8.8 Power Supplies Decoupling and Bypassing

The DAC requires 3 distinct power supplies:

V_{CCA5} = 5.0V (for the analog core)

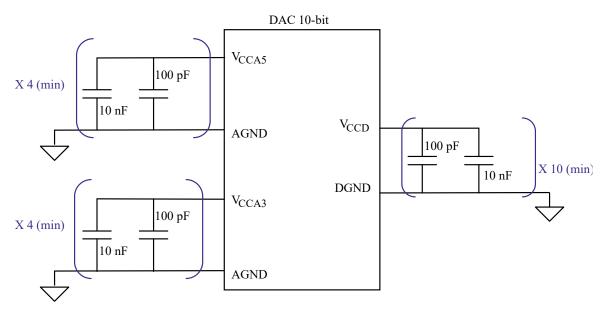
V_{CCA3} = 3.3V (for the analog part)

V_{CCD} = 3.3V (for the digital part)

It is recommended to decouple all power supplies to ground as close as possible to the device balls with 100 pF in parallel to 10nF capacitors. The minimum number of decoupling pairs of capacitors can be calculated as the minimum number of groups of neighboring pins.

4 pairs of 100pF in parallel to 10 nF capacitors are required for the decoupling of V_{CCA5} . 4 pairs for the V_{CCA3} is the minimum required and finally, 10 pairs are necessary for V_{CCD} .





Each power supply has to be bypassed as close as possible to its source or access by 100 nF in parallel to 22 μ F capacitors (value depending of DC/DC regulators).

Analog and digital ground plane should be merged.

8.9 Power Up Sequencing

For EV12DS130B, in case the power supplies implemented **do not short** their outputs to GND during their power-up, no power-up sequence on the DAC is required.

For EV12DS130B, in case the power supplies implemented **are shorting** their outputs to GND during their power-up, specific power solution implementation or power-up sequence is required for the DAC and for V_{CCA3} and V_{CCD} only:

- V_{CCA3} and V_{CCD} should power-up at the same time, hence be generated from the same LDO with separate decoupling; or
- Specific power-up sequence has to be implemented ensuring that the following cases do not occur during the power-up:
 - V_{CCA3} > 1.2V and V_{CCD} shorted to GND
 - V_{CCD} > 1.2V and V_{CCA3} shorted to GND

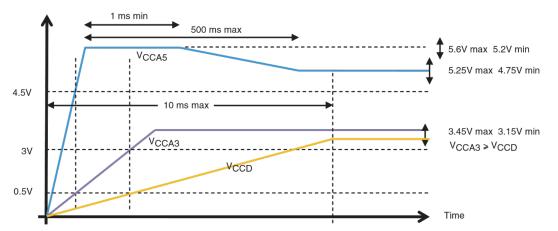
For EV12DS130A the following instructions must be implemented:

Power-up sequence:

It is necessary to raise V_{CCA5} power supply within the range 5.20V up to a recommended maximum of 5.60V during at least 1ms at power up. Then the supply voltage has to settle within 500 ms to a steady nominal supply voltage within a range of 4.75V up to 5.25V.

A power-up sequence on V_{CCA5} that does not comply with the above recommendation will not compromise the functional operation of the device. Only the noise floor will be affected.

Figure 8-12. Power-up Sequence



The rise time for any of the power supplies (V_{CCA5}, V_{CCA3} and V_{CCD}) shall be \leq 10 ms.

At power-up a SYNC pulse is internally and automatically generated when the following sequence is satisfied: V_{CCD} , V_{CCA3} and V_{CCA5} . To cancel the SYNC pulse at power-up, it is necessary to apply the sequence: V_{CCA5} , V_{CCA3} , V_{CCD} . (It is mandatory that V_{CCD} is the last supply to rise and always remains behind V_{CCA5} and V_{CCA3}). Any other sequence may not have a deterministic SYNC behaviour. See erratasheet (ref 1125) for specific condition of use relative to the SYNC operation.

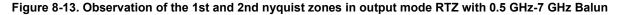
Relationship between power supplies:

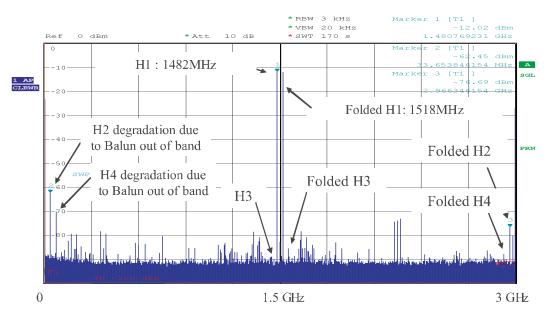
Within the applicable power supplies range, the following relationship shall always be satisfied $V_{CCA3} \ge V_{CCD}$, taking into account AGND and DGND planes are merged and power supplies accuracy.

8.10 Balun Influence

It is important to know that balun characteristic may influence significantly DAC output spectral response. Especially harmonic distortion can dramatically be degraded when part of the band of interest lies out of the specified domain of the balun.

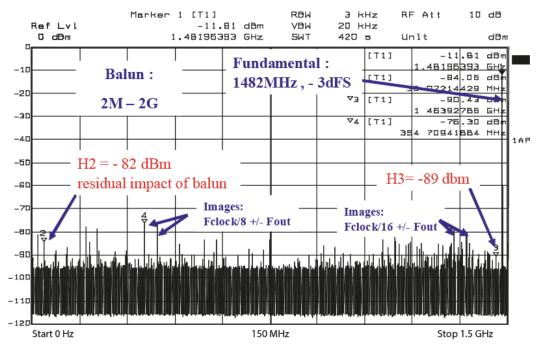
As depicted in the following figure an inappropriate balun choice can result in a strong increase in harmonic peaks amplitude, thus degrading performances. The balun used in this measurement covers only the 500MHz to 7GHz band so that the DC to 500MHz region of the first nyquist zone is distorted.





On the opposite, when appropriate balun is used the real device response is measured.

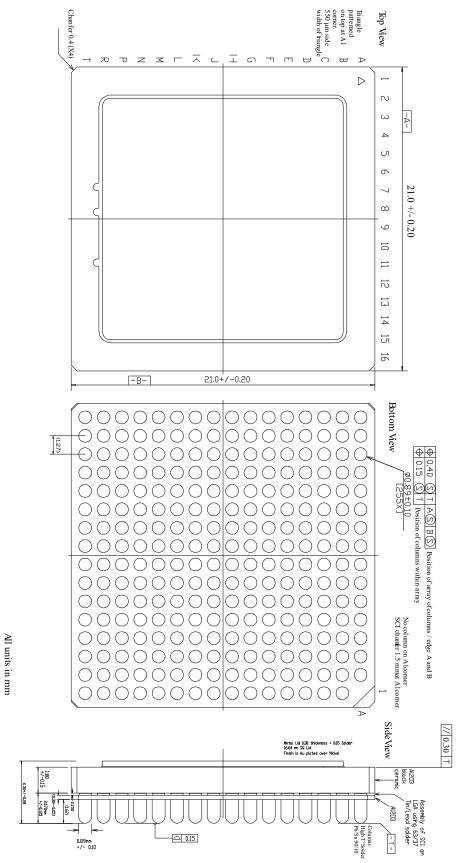




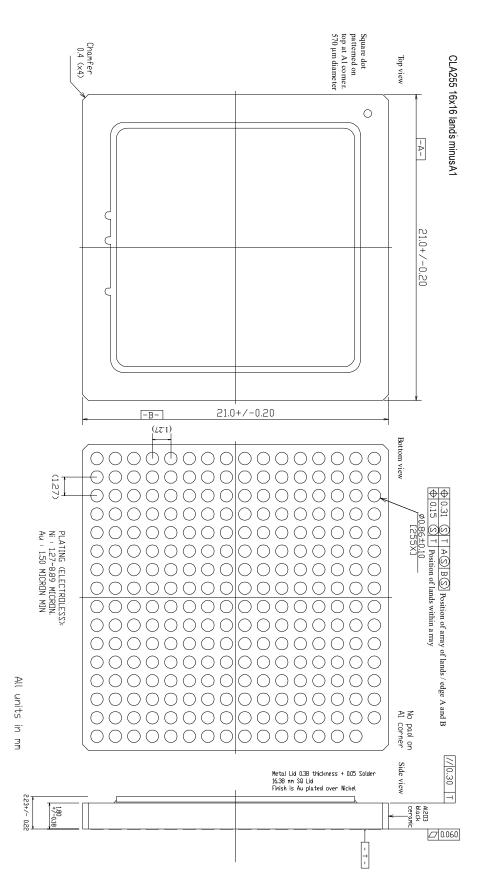
As a consequence, one must be aware that optimum performances can only be reached when using a balun optimal for the band of interest of the application. We specifically recommend selecting a balun which frequency domain covers the whole band of interest (for instance one whole Nyquist zone).

9. PACKAGE DESCRIPTION

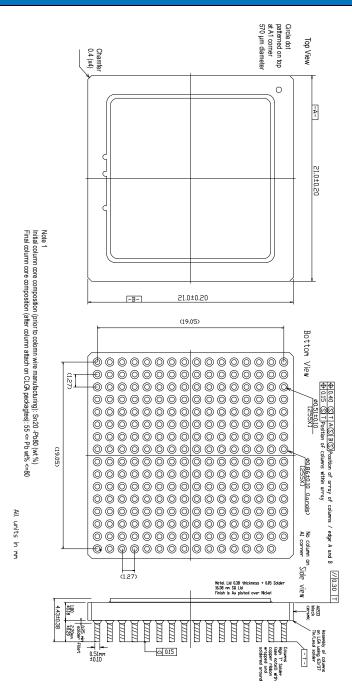
9.1 Ci-CGA255 Outline



9.3 CLGA255 Outline







9.4 Thermal Characteristics Assumptions:

- Die thickness = 300 µm
- No convection
- Pure conduction
- No radiation

Rтн	Heating zone	Ci CGA	CCGA	Unit
Junction-> Bottom of columns		13.8	15.0	°C/W
Junction-> Board (JEDEC JESD51-8) Boad size = 39x39mm, 1.6 mm Thickness)	7.5% die area:	17.1	18.6	°C/W
Junction -> Top of Lid	4580x4580 μm	19.3	22.0	°C/W
T _{jhot} spot – T _{Jdiode}		3.3	3.3	°C/W

Typical Assumptions:

- Convection according to JEDEC
- Still air
- Horizontal 2s2p board
- Board size 114.3 × 76.2 mm, 1.6 mm thickness

R _{TH}	Heating zone	Ci CGA	CCGA	Unit
Junction -> Ambient	7.5% die area:	29.5	29.4	°C/W
T _{jhot} spot – T _{Jdiode}	4580x4580 µm	3.3	3.3	°C/W

10. DIFFERENCES BETWEEN EV12DS130A AND EV12DS130B

EV12DS130A and EV12DS130B exhibit the same dynamic performances.

EV12DS130B requires no specific dependency between power supplies nor power up sequences while the EV12DS130A does require specific power up sequences as described in Section 8.9 on page 68.

Maximum supported sampling frequency with DSP clock feature for EV12DS130B is 2.1GHz due to internal jitter. It is however possible to benefit from the EV12DS130B DAC performances up to 3GHz if specific system architecture is implemented. Please refer to application AN1141 for further information.

No SYNC timing constraints (other than T1 T2) are required on EV12DS130B.

As a summary

When using EV12DS130A, please ensure your system fulfills those specific recommendations

- Power Up Sequence (See Section 8.9 on page 68)
- Power supplies dependency (see Section 8.9 on page 68)
- SYNC pin have to be driven in any case
- Please refer to errata sheet 1125

When using EV12DS130B, please ensure your system fulfills those specific recommendations

• In case sampling frequency is above 2.1 Gsps, please read the AN1141 "Using EV1xDS130B at sampling rate higher than 2.1GSps"

Please refer to application note AN1140 "Replacing EV1xDS130A with EV1xDS130B" for further details.

11. ORDERING INFORMATION

Please refer to datasheet details and application notes before ordering.

Table 11-1. Ordering Information

Part Number	SMD Number	Package	Temperature Range	Screening Level	Comments
	·	EV12DS130AG	·		·
EVX12DS130AGS		CI-CGA255	Ambient	Prototype	
EV12DS130AMGSD/T		CI-CGA255	–55°C < Tc,Tj < 125°C	EQM Grade	
EV12DS130AMGS9NB1		CI-CGA255	–55°C < Tc,Tj < 125°C	Space Grade	
EV12DS130AGS-EB		CI-CGA255	Ambient	Prototype	Evaluation board
EVX12DS130ALG		LGA255	Ambient	Prototype	
EV12DS130AMLGD/T		LGA255	–55°C < Tc,Tj < 125°C	EQM Grade	
EV12DS130AMLG9NB1		LGA255	–55°C < Tc,Tj < 125°C	Space Grade	
EVX12DS130AGC		CCGA255	Ambient	Prototype	
EV12DS130AMGC		CCGA255	–55°C < Tc,Tj < 125°C	Engineering model	
EV12DS130AMGCD/T		CCGA255	–55°C < Tc,Tj < 125°C	EQM Grade	
EV12DS130AMGC9NB1		CCGA255	–55°C < Tc,Tj < 125°C	Space Grade	
EV12DS130AMLG-V	5962-1522201VXC	LGA255	–55°C < Tc,Tj < 125°C	QML-V Grade MIL PRF 38535	
EV12DS130AMGS-V	5962-1522201VYF	CI-CGA255	–55°C < Tc,Tj < 125°C	QML-V Grade MIL PRF 38535	
EV12DS130AMGC-V	5962-1522201VZF	CCGA255	–55°C < Tc,Tj < 125°C	QML-V Grade MIL PRF 38535	
		EV12DS130BG			
EVX12DS130BGS		CI-CGA255	Ambient	Prototype	
EV12DS130BGS-EB		CI-CGA255	Ambient	Prototype	Evaluation board
EVX12DS130BLG		LGA255	Ambient	Prototype	
EV12DS130BMLG		LGA255	–55°C < Tc,Tj < 125°C	Engineering model	
EV12DS130BMLGD/T		LGA255	–55°C < Tc,Tj < 125°C	EQM Grade	
EV12DS130BMLG9NB1		LGA255	–55°C < Tc,Tj < 125°C	Space Grade	
EVX12DS130BGC		CCGA255	Ambient	Prototype	
EV12DS130BMGC		CCGA255	–55°C < Tc,Tj < 125°C	Engineering model	
EV12DS130BMGCD/T		CCGA255	–55°C < Tc,Tj < 125°C	EQM Grade	
EV12DS130BMGC9NB1		CCGA255	–55°C < Tc,Tj < 125°C	Space Grade	
EV12DS130BMLG-V	5962-1522202VXC	LGA255	–55°C < Tc,Tj < 125°C	QML-V Grade MIL PRF 38535	
EV12DS130BMGSD/T		CI-CGA255	–55°C < Tc,Tj < 125°C	EQM Grade	
EV12DS130BMGS9NB1		CI-CGA255	–55°C < Tc,Tj < 125°C	Space Grade	
EV12DS130BMGS-V	5962-1522202VYF	CI-CGA255	–55°C < Tc,Tj < 125°C	QML-V Grade MIL PRF 38535	
EV12DS130BMGC-V	5962-1522202VZF	CCGA255	–55°C < Tc,Tj < 125°C	QML-V Grade MIL PRF 38535	

12. REVISION HISTORY

This table provides revision history for this document.

Table 12-1. Revision History

Rev. No	Date	Substantive Change(s)
DS 60S 221070 (O)	August 2023	Table 3-8 on page 11 Change T1 typical value to 350ps Change T2 typical value to 330ps Modify note 5 to: "The SYNC signal is captured on the falling edge of the master clock and is active high. Refer to Figure 3-3.
		Replace Figure 3-3. SYNC Timing Diagram on page 12
DS 60S 221070 (N)	September 2021	Change of the document reference Table 11-1, "Ordering Information," on page 74: 2 missing part numbers added
1080M	June 2019	Section 8.9 "Power Up Sequencing" on page 68: Additional information on power-up conditions for EV12DS130B
1080L	December 2018	Section 9.4 "Thermal Characteristics" on page 73: Correction RTH Junction -> Ambient heating zone area
1080K	January 2018	Table 11-1, "Ordering Information," on page 74: Remove "Pending qualification / contact Marketing" in the Comments column
1080J	September 2016	Table 11-1, "Ordering Information," on page 74: Correction of EV12DS130B SMD Numbers 1522201 instead of 1522202
10801	August 2016	Table 11-1, "Ordering Information," on page 74: Introduction of QML-V grade for EV12DS130B Typo correction
1080H	March 2016	Introduction of QML-V grade and add EV12DS130AMGC
1080G	December 2014	Section 5.6 on page 24: OCDS [10] not allowed Introduction and description of EV12DS130B New Section 10. "Differences between EV12DS130A and EV12DS130B" on page 73 Table 3-6, "AC Electrical Characteristics RTZ Mode (Second Nyquist Zone)(2)," on page 9: Limits update Table 3-9, "Coding Table (Theorical values)," on page 13: typo error on lines (RTZ) and (NRTZ) Section 5.1 "DSP Output Clock" on page 16 updated Section 5.3 "MODE Function" on page 16: equations updated Section 5.5 "PSS (Phase Shift Select Function)" on page 23 updated Section 5.9 "Synchronization functions for multi-DAC operation" on page 28 updated Figure 7-5 on page 38 updated Figure 7-13 on page 41 updated New Section 7.2.3 "Single tone measurements: typical spectra at 3Gsps" on page 45 New Section 8.10 "Balun Influence" on page 74
1080F	May 2014	Table 3-3: Change max current ICCD limit (2:1 & 4:1 MUX mode)Table 3-3: Output internal differential resistor is test level 1 & 6figureTable 3-6: remove minimum limit on SFDR in 4:1 MUX modeFs = 3Gsps @ Fout = 1600MHz 0 dBFS (now test level 4)Table 3-6: remove maximum limit on highest spur level in 4:1 MUX modeFs = 3Gsps @ Fout = 1600MHz 0 dBFS (now test level 4)Table 3-8: provide min & max limits for Input data rate in 2:1 and 4:1 MUX mode. Table 3-8:Delay TDP is renamed TPD. It is a typ value and not a max value Section 4. "Definition ofTerms" on page 14:TOD definition is replace by TPD/TOD definition for clarificationTypo correction on RTZ and NRTZ termFigure 8-11: modification of power supplies decoupling scheme on V _{CCA3} and V _{CCD} Typo errors

EV12DS130AG/EV12DS130BG

Rev. No	Date	Substantive Change(s)
1080E	December 2013	Typo errors correction in formula of Section 5.3 "MODE Function" on page 16 and Section 5.6 "Output Clock Division Select Function" on page 24 Section 9.3 "CCGA255 Outline" on page 71 CCGA Outline drawing Table 3-2, "Recommended Conditions of Use," on page 4: typo errors on note 2: $V_{CCA3} \ge V_{CCD}$ Table 3-3, "Electrical Characteristics," on page 5: typo errors on note 7: $V_{CCA3} \ge V_{CCD}$
1080D	July 2013	Typo errors OCDS restrictions HTVF STVF flag application clarification Power sequencing modification. Sync operation clarification. Add LGA and CCGA outline drawing
1080C	July 2012	Typo errors absolute max rating clarifications addition of pin equivalent schematic description Power sequencing recommendation
1080B	February 2012	Typo errors Rth adjustement.
1080A	February 2012	Initial Revision

Table of Contents

1.	BLOCK DIAGRAM	2
2.	DESCRIPTION	2
3.	ELECTRICAL CHARACTERISTICS	3
3.1	Absolute Maximum Ratings	3
3.2	Recommended Conditions of Use	4
3.3	Electrical Characteristics	5
3.4	AC Electrical Characteristics	7
3.5	Timing Characteristics and Switching Performances	11
3.6	Explanation of Test Levels	13
3.7	Digital Input Coding Table	13
4.	DEFINITION OF TERMS	14
5.	FUNCTIONAL DESCRIPTION	15
5.1	DSP Output Clock	16
5.2	Multiplexer	16
5.3	MODE Function	16
5.3	3.1 NRZ Output Mode	19
5.3	3.2 Narrow RTZ Mode (NRTZ Mode)	19
5.3	3.3 RTZ Mode	20
5.3		
5.4	Input Under Clocking Mode (IUCM), Principle and Spectral Response	
5.5	PSS (Phase Shift Select Function)	
5.6	Output Clock Division Select Function	04
5.0	•	
5.7	Synchronization FPGA-DAC: IDC_P, IDC_N, HTVF and STVF Functions IDC_P, IDC_N: Input Data check function S signal)	n
5.7	Synchronization FPGA-DAC: IDC_P, IDC_N, HTVF and STVF Functions IDC_P, IDC_N: Input Data check function	n 26
5.7 (LVD	Synchronization FPGA-DAC: IDC_P, IDC_N, HTVF and STVF Functions IDC_P, IDC_N: Input Data check function S signal) OCDS, MUX Combinations Summary Synchronization functions for multi-DAC operation	n 26 27 28
5.7 (LVD 5.8	Synchronization FPGA-DAC: IDC_P, IDC_N, HTVF and STVF Functions IDC_P, IDC_N: Input Data check function S signal) OCDS, MUX Combinations Summary	n 26 27 28
5.7 (LVD 5.8 5.9	Synchronization FPGA-DAC: IDC_P, IDC_N, HTVF and STVF Functions IDC_P, IDC_N: Input Data check function S signal) OCDS, MUX Combinations Summary Synchronization functions for multi-DAC operation	n 26 27 28 29
5.7 (LVD 5.8 5.9 5.10	Synchronization FPGA-DAC: IDC_P, IDC_N, HTVF and STVF Functions IDC_P, IDC_N: Input Data check function S signal). OCDS, MUX Combinations Summary. Synchronization functions for multi-DAC operation. Gain Adjust GA Function.	n 26 27 28 29 29
5.7 (LVD) 5.8 5.9 5.10 5.11	Synchronization FPGA-DAC: IDC_P, IDC_N, HTVF and STVF Functions IDC_P, IDC_N: Input Data check function S signal) OCDS, MUX Combinations Summary Synchronization functions for multi-DAC operation Gain Adjust GA Function Diode Function	n 26 27 28 29 29 30
5.7 (LVD 5.8 5.9 5.10 5.11 6.	Synchronization FPGA-DAC: IDC_P, IDC_N, HTVF and STVF Functions IDC_P, IDC_N: Input Data check function S signal). OCDS, MUX Combinations Summary. Synchronization functions for multi-DAC operation. Gain Adjust GA Function. Diode Function.	n 26 27 28 29 29 30 36
5.7 (LVD 5.8 5.9 5.10 5.11 6. 7.	Synchronization FPGA-DAC: IDC_P, IDC_N, HTVF and STVF Functions IDC_P, IDC_N: Input Data check function S signal) OCDS, MUX Combinations Summary Synchronization functions for multi-DAC operation Gain Adjust GA Function Diode Function PIN DESCRIPTION CHARACTERIZATION RESULTS Static Performances	n 26 27 28 29 29 30 36 36
5.7 (LVD 5.8 5.9 5.10 5.11 6. 7. 7.1	Synchronization FPGA-DAC: IDC_P, IDC_N, HTVF and STVF Functions IDC_P, IDC_N: Input Data check function S signal) OCDS, MUX Combinations Summary Synchronization functions for multi-DAC operation Gain Adjust GA Function Diode Function PIN DESCRIPTION CHARACTERIZATION RESULTS Static Performances	n 26 27 28 29 30 36 36 36
5.7 (LVD 5.8 5.9 5.10 5.11 6. 7. 7.1 7.1 7.1	Synchronization FPGA-DAC: IDC_P, IDC_N, HTVF and STVF Functions IDC_P, IDC_N: Input Data check function S signal) OCDS, MUX Combinations Summary Synchronization functions for multi-DAC operation Gain Adjust GA Function Diode Function PIN DESCRIPTION CHARACTERIZATION RESULTS Static Performances	n 26 27 28 29 30 36 36 36 37
5.7 (LVD 5.8 5.9 5.10 5.11 6. 7. 7.1 7.1 7.1	Synchronization FPGA-DAC: IDC_P, IDC_N, HTVF and STVF Functions IDC_P, IDC_N: Input Data check function S signal)	n 26 27 29 30 36 36 36 37 38 38
5.7 (LVD 5.8 5.9 5.10 5.11 6. 7. 7.1 7.1 7.1 7.2	Synchronization FPGA-DAC: IDC_P, IDC_N, HTVF and STVF Functions IDC_P, IDC_N: Input Data check function S signal)	n 26 27 28 29 30 36 36 36 36 36 36 38 38 38
5.7 (LVD 5.8 5.9 5.10 5.11 6. 7. 7.1 7.1 7.1 7.2 7.2	Synchronization FPGA-DAC: IDC_P, IDC_N, HTVF and STVF Functions IDC_P, IDC_N: Input Data check function S signal)	n 26 27 29 29 30 36 36 36 36 38 38 38 38 38
5.7 (LVD 5.8 5.9 5.10 5.11 6. 7.1 7.1 7.1 7.2 7.2 7.2 7.2 7.2 7.2	Synchronization FPGA-DAC: IDC_P, IDC_N, HTVF and STVF Functions IDC_P, IDC_N: Input Data check function S signal) OCDS, MUX Combinations Summary Synchronization functions for multi-DAC operation Gain Adjust GA Function Diode Function PIN DESCRIPTION CHARACTERIZATION RESULTS. Static Performances 1.1 DC Gain Characterization 1.2 Static Linearity AC Performances 2.1 Available Output Power vs Fout 2.2 Single Tone Measurements 2.3 Single tone measurements: typical spectra at 3Gsps 2.4 Multi Tone Measurements.	n 26 27 28 29 30 36 36 36 37 38 38 38 40 45 48
5.7 (LVD 5.8 5.9 5.10 5.11 6. 7. 7.1 7.1 7.2 7.2 7.2 7.2 7.2 7.2 7.2 7.2	Synchronization FPGA-DAC: IDC_P, IDC_N, HTVF and STVF Functions IDC_P, IDC_N: Input Data check function Signal). OCDS, MUX Combinations Summary Synchronization functions for multi-DAC operation. Gain Adjust GA Function Dide Function PIN DESCRIPTION CHARACTERIZATION RESULTS Static Performances 1.1 DC Gain Characterization 1.2 Static Linearity AC Performances 2.1 Available Output Power vs Fout. 2.2 Single Tone Measurements 2.3 Single tone measurements: typical spectra at 3Gsps 2.4 Multi Tone Measurements. 2.5 Direct Microwave Synthesis Capability Measurements: ACPR.	n 26 27 29 29 30 36 36 36 36 38 38 38 38 38 38 38 38 38 31
5.7 (LVD 5.8 5.9 5.10 5.11 6. 7.1 7.1 7.1 7.2 7.2 7.2 7.2 7.2 7.2	Synchronization FPGA-DAC: IDC_P, IDC_N, HTVF and STVF Functions IDC_P, IDC_N: Input Data check function S signal). OCDS, MUX Combinations Summary Synchronization functions for multi-DAC operation	n 26 27 29 29 30 36 36 36 37 38 38 31 40 45 45 45 51
5.7 (LVD 5.8 5.9 5.10 5.11 6. 7. 7.1 7.1 7.2 7.2 7.2 7.2 7.2 7.2 7.2 7.2 7.2 7.2	Synchronization FPGA-DAC: IDC_P, IDC_N, HTVF and STVF Functions IDC_P, IDC_N: Input Data check function OCDS, MUX Combinations Summary Synchronization functions for multi-DAC operation Gain Adjust GA Function Diode Function PIN DESCRIPTION CHARACTERIZATION RESULTS Static Performances 1.1 DC Gain Characterization 1.2 Static Linearity AC Performances 2.1 Available Output Power vs Fout 2.2 Single tone measurements: 2.3 Single tone measurements 2.4 Multi Tone Measurements 2.5 Direct Microwave Synthesis Capability Measurements: ACPR 2.6 DOCSIS v3.0 Capability Measurements. 2.7 NPR Performance.	n 26 27 29 29 30 36 36 36 36 36 36 36 36 37 38 40 45 41 51 54 57
5.7 (LVD 5.8 5.9 5.10 5.11 6. 7. 7.1 7.1 7.1 7.2 7.2 7.2 7.2 7.2 7.2 7.2 7.2	Synchronization FPGA-DAC: IDC_P, IDC_N, HTVF and STVF Functions IDC_P, IDC_N: Input Data check function OCDS, MUX Combinations Summary Synchronization functions for multi-DAC operation Gain Adjust GA Function Diode Function PIN DESCRIPTION CHARACTERIZATION RESULTS Static Performances 1.1 DC Gain Characterization 1.2 Static Linearity AC Performances 2.1 Available Output Power vs Fout. 2.2 Single tone measurements 2.3 Single tone measurements 2.4 Multi Tone Measurements 2.5 Direct Microwave Synthesis Capability Measurements: ACPR 2.6 DOCSIS v3.0 Capability Measurements 2.7 NPR Performance	n 26 27 28 29 30 36 36 36 36 37 38 38 40 45 45 45 51 54 57 61

EV12DS130AG/EV12DS130BG

Analog Output (OUT/OUTN)	63
Clock Input (CLK/CLKN)	64
Digital Data, SYNC and IDC Inputs	65
DSP Clock	
Control Signal Settings	66
HTVF and STVF Control Signal	66
GA Function Signal	67
Power Supplies Decoupling and Bypassing	67
Power Up Sequencing	68
0 Balun Influence	69
PACKAGE DESCRIPTION	70
Ci-CGA255 Outline	70
CLGA255 Outline	71
Thermal Characteristics Assumptions:	73
DIFFERENCES BETWEEN EV12DS130A AND EV12DS130B	73
ORDERING INFORMATION	74
REVISION HISTORY	75
	Clock Input (CLK/CLKN) Digital Data, SYNC and IDC Inputs DSP Clock Control Signal Settings HTVF and STVF Control Signal GA Function Signal Power Supplies Decoupling and Bypassing Power Up Sequencing 0 Balun Influence PACKAGE DESCRIPTION Ci-CGA255 Outline CLGA255 Outline Thermal Characteristics Assumptions: DIFFERENCES BETWEEN EV12DS130A AND EV12DS130B

IMPORTANT NOTICE

Teledyne e2v provides technical and reliability data, including datasheets, design resources, application and other recommendations ("Resources") "as is" at the date of its disclosure. All Teledyne e2v Resources are subject to change without notice to improve reliability, function or design, or otherwise.

These Resources are intended for skilled developers designing with Teledyne e2v products. You are solely responsible for a. selecting the appropriate Teledyne e2v products for your application, b. designing, validating and testing your application, and c. ensuring your application meets applicable standards, and any other safety, security, or other requirements.

Teledyne e2v makes no warranty, representation or guarantee regarding the suitability of these Resources for any particular purpose, or the continuing production of any of its products. Teledyne e2v grants you permission to use these Resources only for the development of an application that uses the Teledyne e2v products described in the Resource. Other reproduction and display of these Resources are not permitted. No license, express or implied, to Teledyne e2vintellectual property right or to any third party intellectual property right is granted by this document or by the conduct of Teledyne e2v.

To the maximum extent permitted by law, Teledyne e2v disclaims (i) any and all liability for any errors, inaccuracies or incompleteness contained in these Resources, or arising out of the application of or use of these Resources, and (ii) any and all express or implied warranties, including those of merchantability, fitness for a particular purpose or non-infringement of intellectual property rights. You shall fully indemnify Teledyne e2v against, any claims, damages, costs, losses, and liabilities arising out of your application of or use of these Resources.

Teledyne e2v's acceptance of any products purchase orders is expressly conditioned upon your assent to Teledyne e2v's General Terms and Conditions of Sale which are stated in any Teledyne e2v's offer and can be found at www.teledyne-e2v.com/about-us/terms-and-conditions/.

The provision of these Resources by Teledyne e2v does not expand or otherwise alter Teledyne e2v's applicable warranties or warranty disclaimers for Teledyne e2v products.

Mailing Address: Teledyne e2v Semiconductors SAS, Avenue de Rochepleine, 38120 Saint Egrève, France. Telephone: +33 4 76 58 30 00 e-mail: <u>gre-hotline-bdc@teledyne.com</u> Copyright © 2023, Teledyne e2v Semiconductors SAS